





**DLPA3005** DLPS071A - OCTOBER 2015 - REVISED FEBRUARY 2023

# **DLPA3005 PMIC and High-Current LED Driver IC**

### 1 Features

- High-efficiency, high-current RGB LED driver
- Drivers for external buck FETs up to 16 A
- Drivers for external RGB switches
- 10-bit programmable current per channel
- Inputs to select color-sequential RGB LEDs
- Generation of DMD high voltage supplies
- Two high efficiency buck converters to generate the DLPC343x and DMD supply
- One high efficiency, 8-bit programmable buck converter for fan driver application or general power supply. General purpose buck2 (PWR6) is currently supported.
- Two LDOs supplying auxiliary voltages
- Analog MUX for measuring internal and external nodes such as a thermistor and reference levels
- Monitoring/protections: thermal shutdown, hot die, and undervoltage lockout (UVLO)

## 2 Applications

Portable DLP® Pico™ projectors

## 3 Description

DLPA3005 is highly-integrated а management IC optimized for DLP® Pico™ Projector systems. The DLPA3005 supports LED projectors up to 16 A per LED and up to 32 A for series LEDs, enabled by an integrated high efficiency buck controller. Additionally, the drivers control the RGB switches, supporting the sequencing of R, G, and B LEDs. The DLPA3005 contains five buck converters, two of which are dedicated for DLPC low voltage supplies. Another dedicated regulating supply generates the three timing-critical DC supplies for the DMD: VBIAS, VRST, and VOFS.

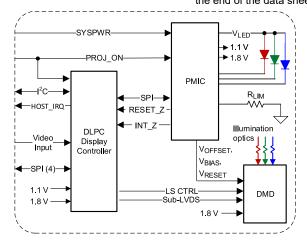
The DLPA3005 contains several auxiliary blocks which can be used in a flexible way. This enables a tailor-made Pico Projector system. One 8-bit programmable buck converter can be used, for instance, to drive rgb projector FAN or to make auxiliary supply line. General purpose buck2 (PWR6) is currently supported. Two LDOs can be used for a lower-current supply, up to 200 mA. These LDOs are predefined to 2.5 V and 3.3 V.

Through the SPI, all blocks of the DLPA3005 can be addressed. Features included are the generation of the system reset, power sequencing, input signals for sequentially selecting the active LED, IC selfprotections, and an analog MUX for routing analog information to an external ADC.

### **Device Information**

PART NUMBER	PACKAGE	BODY SIZE (NOM)
DLPA3005 <sup>(1)</sup>	HTQFP (100)	14.00 mm × 14.00 mm

For all available packages, see the orderable addendum at the end of the data sheet.



Typical, Simplified System



## **Table of Contents**

1 Features1	8.2 Typical Application	. 45
2 Applications 1	8.3 System Example With DLPA3005 Internal Block	
3 Description1	Diagram	48
4 Revision History2	9 Power Supply Recommendations	
5 Pin Configuration and Functions4	9.1 Power-Up and Power-Down Timing	50
6 Specifications8	10 Layout	53
6.1 Absolute Maximum Ratings8	10.1 Layout Guidelines	53
6.2 ESD Ratings9	10.2 Layout Example	56
6.3 Recommended Operating Conditions9	10.3 Thermal Considerations	56
6.4 Thermal Information9	11 Device and Documentation Support	59
6.5 Electrical Characteristics10	11.1 Device Support	59
6.6 SPI Timing Parameters16	11.2 Third-Party Products Disclaimer	. 59
7 Detailed Description17	11.3 Related Links	. 59
7.1 Overview17	11.4 Receiving Notification of Documentation Updates.	59
7.2 Functional Block Description17	11.5 Support Resources	. 59
7.3 Feature Description18	11.6 Trademarks	60
7.4 Device Functional Modes37	11.7 Electrostatic Discharge Caution	60
7.5 Programming39	11.8 Glossary	60
7.6 Register Maps43	12 Mechanical, Packaging, and Orderable	
8 Application and Implementation45	Information	60
8.1 Application Information45	12.1 Package Option Addendum	61

# **4 Revision History**

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

•	Removed unsupported General Purpose Buck Converters and battery mode in Features	1
•	Block Diagram in Description	
		1
•	Updated Pin Configuration and Functions	4
•	Removed INT_Z from Input Voltage range Table and updated the max value of CH1,2,3_SWITCH,	
	ILLUM_A,B_FB in Recommended Operating Conditions	9
•	Updated with new support for series LEDs, removed unsupported General Purpose Buck Converters in	
	Electrical Characteristics	
•	Removed unsupported General Purpose Buck Converters and battery mode in Overview	17
•	Updated the System Block Diagram in Functional Block Description	17
•	Removed unsupported General Purpose Buck Converters in Supply	18
•	Updated register names in Monitoring	
•	Removed battery mode in Auto LED Turn Off Functionality	20
•	Updated with new support for series LEDs in RGB Strobe Decoder	25
•	Updated Break Before Make (BBM)	26
•	Updated register name in Openloop Voltage	26
•	Updated register name in Illumination Monitoring	<mark>27</mark>
•	Updated register names in Power Good	27
•	Updated register name in DMD Supplies	30
•	Removed unsupported General Purpose Buck Converters in DMD/DLPC Buck Converters	31
•	Updated register name in DMD Monitoring	33
•	Removed unsupported General Purpose Buck Converters 1 and 3 in Buck Converters	34
•	Removed unsupported General Purpose Buck Converters in LDO Bucks	34
•	Removed unsupported General Purpose Buck Converters 1 and 3 and updated register names in General	ral
	Purpose Buck Converter	34
•	Removed unsupported General Purpose Buck Converters 1 and 3 in Buck Converter Monitoring	35
•	Removed unsupported General Purpose Buck Converters 1 and 3 in Power Good	35



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•	Removed light sensor use-case and updated register names in Measurement System	36
•	Removed unsupported General Purpose Buck Converters and battery mode in Interrupt	
•	Updated Register Maps	43
•	Updated Application Information for a series LED use case	
•	Updated the System Block Diagram in Typical Application	45
•	Removed unsupported General Purpose Buck Converters and battery mode in Design Requirements	
•	Updated System Example With DLPA3005 Internal Block Diagram	48
•	Removed battery mode in Power Supply Recommendations	49
•	Updated the High AC Current Paths in a Buck Converter Diagram and removed battery mode in Layout	
	Guidelines	53
•	Removed unsupported General Purpose Buck Convert in SPI Connections	54
•	Updated R <sub>LIM</sub> Routing	54
•	Updated LED Connection	
•	Updated Layout Example	<mark>56</mark>
•	Updated Thermal Considerations	56



## **5 Pin Configuration and Functions**

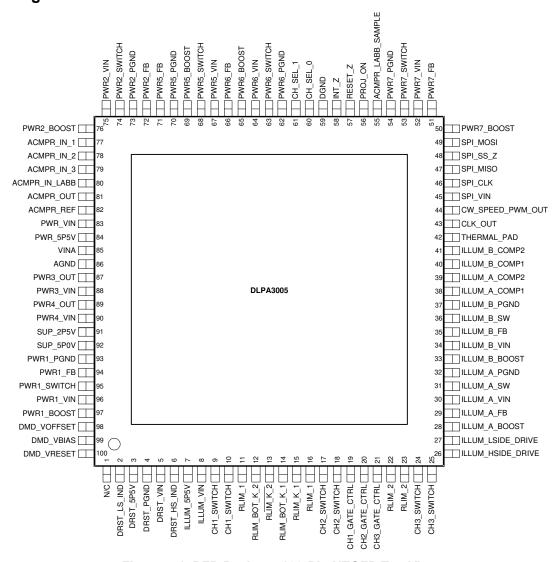


Figure 5-1. PFD Package 100-Pin HTQFP Top View

Table 5-1. Pin Functions

PIN		I/O	DESCRIPTION	
NAME	NO.	"0	DESCRIPTION	
N/C	1	_	No connect	
DRST_LS_IND	2	I/O	Connection for the DMD SMPS-inductor (low-side switch)	
DRST_5P5V	3	0	Filter pin for LDO DMD. Power supply for internal DMD reset regulator, typical 5.5 V	
DRST_PGND	4	GND	Power ground for DMD SMPS. Connect to ground plane.	
DRST_VIN	5	POWER	Power supply input for LDO DMD. Connect to system power.	
DRST_HS_IND	6	I/O	Connection for the DMD SMPS-inductor (high-side switch)	
ILLUM_5P5 V	7	0	Filter pin for LDO ILLUM. Power supply for internal ILLUM block, typical 5.5 V	
ILLUM_VIN	8	POWER	Supply input of LDO ILLUM. Connect to system power.	
CH1_SWITCH	9	I	Low-side MOSFET switch for LED Cathode. Connect to RGB LED assembly.	
CH1_SWITCH	10	I	Low-side MOSFET switch for LED Cathode. Connect to RGB LED assembly.	
RLIM_1	11	0	Connection to LED current sense resistor for CH1 and CH2	
RLIM_BOT_K_2	12	I	Kelvin sense connection to ground side of LED current sense resistor	

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## **Table 5-1. Pin Functions (continued)**

PIN			able 5-1. Fill Fullctions (continued)		
NAME	NO.	I/O	DESCRIPTION		
RLIM_K_2	13	I	Kelvin sense connection to top side of current sense resistor		
RLIM_BOT_K_1	14	I	Kelvin sense connection to ground side of LED current sense resistor		
RLIM_K_1	15	ı	Kelvin sense connection to top side of current sense resistor		
RLIM_1	16	0	Connection to LED current sense resistor for CH1 and CH2		
CH2_SWITCH	17	I	Low-side MOSFET switch for LED cathode. Connect to RGB LED assembly.		
CH2_SWITCH	18	ı	Low-side MOSFET switch for LED cathode. Connect to RGB LED assembly.		
CH1_GATE_CTRL	19	0	Gate control of CH1 external MOSFET switch for LED cathode		
CH2_GATE_CTRL	20	0	Gate control of CH2 external MOSFET switch for LED cathode		
CH3_GATE_CTRL	21	0	Gate control of CH3 external MOSFET switch for LED cathode		
RLIM_2	22	0	Connection to LED current sense resistor for CH3		
RLIM_2	23	0	Connection to LED current sense resistor for CH3		
CH3_SWITCH	24	I	Low-side MOSFET switch for LED Cathode. Connect to RGB LED assembly.		
CH3_SWITCH	25	I	Low-side MOSFET switch for LED Cathode. Connect to RGB LED assembly.		
ILLUM_HSIDE_DRIVE	26	0	Gate control for external high-side MOSFET for ILLUM Buck converter		
ILLUM_LSIDE_DRIVE	27	0	Gate control for external low-side MOSFET for ILLUM Buck converter		
ILLUM_A_BOOST	28	I	Supply voltage for high-side N-channel MOSFET gate driver. A 100-nF capacitor (typical) must be connected between this pin and ILLUM_A_SW.		
ILLUM_A_FB	29	ı	Input to the buck converter loop controlling I <sub>LED</sub>		
ILLUM_A_VIN	30	POWER	Power input to the ILLUM Driver A		
ILLUM_A_SW	31	I/O	Switch node connection between high-side NFET and low-side NFET. Serves as common connection for the flying high side FET driver		
ILLUM_A_PGND	32	GND	Ground connection to the ILLUM Driver A		
ILLUM_B_BOOST	33	ı	Supply voltage for high-side N-channel MOSFET gate driver		
ILLUM_B_VIN	34	POWER	Power input to the ILLUM driver B		
ILLUM_B_FB	35	I	Input to the buck converter loop controlling I <sub>LED</sub>		
ILLUM_B_SW	36	I/O	Switch node connection between high-side NFET and low-side NFET		
ILLUM_B_PGND	37	GND	Ground connection to the ILLUM driver B		
ILLUM_A_COMP1	38	I/O	Connection node for feedback loop components		
ILLUM_A_COMP2	39	I/O	Connection node for feedback loop components		
ILLUM_B_COMP1	40	I/O	Connection node for feedback loop components		
ILLUM_B_COMP2	41	I/O	Connection node for feedback loop components		
THERMAL_PAD	42	GND	Thermal pad. Connect to a clean system ground.		
CLK_OUT	43	0	No connect. Reserved for color wheel clock output		
CW_SPEED_PWM_OUT	44	0	No connect. Reserved for color wheel PWM output		
SPI_VIN	45	I	Supply for SPI interface		
SPI_CLK	46	I	SPI clock input		
SPI_MISO	47	0	SPI data output		
SPI_SS_Z	48	ı	SPI chip select (active low)		
SPI_MOSI	49	I	SPI data input		
PWR7_BOOST	50	I	Reserved for general purpose buck converter. Charge-pump-supply input for the high-side FET gate drive circuit. Connect 100-nF capacitor between PWR7_BOOST and PWR7_SWITCH pins.		
PWR7_FB	51	I	Reserved for general purpose buck converter. Converter feedback input. Connect to converter output voltage.		
PWR7_VIN	52	POWER	Reserved for general purpose buck converter. Power supply input for converter		



## **Table 5-1. Pin Functions (continued)**

PIN			able 5-1. Fill Fullctions (continued)	
NAME NO.		I/O	DESCRIPTION	
PWR7_SWITCH	53	I/O	Reserved for general purpose buck converter. Switch node connection between high-side NFET and low-side NFET	
PWR7_PGND	54	GND	Reserved for general purpose buck converter. Ground pin. Power ground return for switching circuit	
ACMPR_LABB_SAMPLE	55	ı	Control signal to sample voltage at ACMPR_IN_LABB	
PROJ_ON	56	ı	Input signal to enable and or disable the IC and DLP projector	
RESET_Z	57	0	Reset output to the DLP system (active low). The pin is held low to reset DLP system.	
INT_Z	58	0	Interrupt output signal (open drain, active low). Connect to the pullup resistor.	
DGND	59	GND	igital ground. Connect to ground plane.	
CH_SEL_0	60	I	Control signal to enable either of CH1,2,3	
CH_SEL_1	61	I	Control signal to enable either of CH1,2,3	
PWR6_PGND	62	GND	Ground pin. Power ground return for switching circuit	
PWR6_SWITCH	63	I/O	Switch node connection between high-side NFET and low-side NFET	
PWR6_VIN	64	POWER	Power supply input for converter	
PWR6_BOOST	65	I	Charge-pump-supply input for the high-side FET gate drive circuit. Connect a 100-nF capacitor between PWR6_BOOST and PWR6_SWITCH pins.	
PWR6_FB	66	ı	Converter feedback input. Connect to output voltage.	
PWR5_VIN	67	POWER	Reserved for general purpose buck converter. Power supply input for converter	
PWR5_SWITCH	68	I/O	Reserved for general purpose buck converter. Switch node connection between high-side NFET and low-side NFET	
PWR5_BOOST	69	I	Reserved for general purpose buck converter. Charge-pump-supply input for the high-side FET gate drive circuit. Connect the 100-nF capacitor between PWR5_BOOST and PWR5_SWITCH pins.	
PWR5_PGND	70	GND	Reserved for general purpose buck converter. Ground pin. Power ground return for switching circuit	
PWR5_FB	71	I	Reserved for general purpose buck converter. Converter feedback input. Connect to output voltage.	
PWR2_FB	72	I	Converter feedback input. Connect to output voltage.	
PWR2_PGND	73	GND	Ground pin. Power ground return for switching circuit	
PWR2_SWITCH	74	I/O	Switch node connection between high-side NFET and low-side NFET	
PWR2_VIN	75	POWER	Power supply input for converter	
PWR2_BOOST	76	1	Charge-pump-supply input for the high-side FET gate drive circuit. Connect a 100-nF capacitor between PWR2_BOOST and PWR2_SWITCH pins.	
ACMPR_IN_1	77	ı	Reserved. Input for analog sensor signal	
ACMPR_IN_2	78	ı	Input for analog sensor signal	
ACMPR_IN_3	79	ı	Input for analog sensor signal	
ACMPR_IN_LABB	80	ı	Input for ambient light sensor, sampled input	
ACMPR_OUT	81	0	Analog comparator out	
ACMPR_REF	82	ı	Reference voltage input for analog comparator	
PWR_VIN	83	POWER	Power supply input for LDO_bucks. Connect to system power.	
PWR_5P5V	84	0	Filter pin for LDO_BUCKS. Internal analog supply for buck converters, typical 5.5 V	
VINA	85	POWER	Input voltage supply pin for reference system	
AGND	86	GND	Analog ground pin	
PWR3_OUT	87	0	Filter pin for LDO_2 DMD/DLPC/AUX, typical 2.5 V	
PWR3_VIN	88	POWER	Power supply input for LDO_2. Connect to system power.	
PWR4_OUT	89	0	Filter pin for LDO_1 DMD/DLPC/AUX, typical 3.3 V	
PWR4_VIN	90	POWER	Power supply input for LDO_1. Connect to system power.	



## **Table 5-1. Pin Functions (continued)**

PIN		I/O	DESCRIPTION	
NAME	NO.	1/0	DESCRIPTION	
SUP_2P5V	91	0	Filter pin for LDO_V2V5. Internal supply voltage, typical 2.5 V	
SUP_5P0V	92	0	Filter pin for LDO_V5V. Internal supply voltage, typical 5 V	
PWR1_PGND	93	GND	Ground pin. Power ground return for switching circuit	
PWR1_FB	94	I	Converter feedback input. Connect to output voltage.	
PWR1_SWITCH	95	I/O	Switch node connection between high-side NFET and low-side NFET	
PWR1_VIN	96	POWER	Power supply input for converter	
PWR1_BOOST 97		I	Charge-pump-supply input for the high-side FET gate drive circuit. Connect an100-nF capacitor between PWR1_BOOST and PWR1_SWITCH pins.	
DMD_VOFFSET 98 O VOFS output rail. Connect to ceramic capacitor.		VOFS output rail. Connect to ceramic capacitor.		
DMD_VBIAS	99	0	VBIAS output rail. Connect to ceramic capacitor.	
DMD_VRESET 100 O VRESET output rail. Connect to ceramic capacitor.		VRESET output rail. Connect to ceramic capacitor.		

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7



## **6 Specifications**

## **6.1 Absolute Maximum Ratings**

Over operating free-air temperature (unless otherwise noted)(1)

		MIN	MAX	UNIT	
	ILLUM_A,B_BOOST	-0.3	28		
	ILLUM_A,B_BOOST (10 ns transient)	-0.3	30		
	ILLUM_A,B_BOOST vs ILLUM_A,B_SWITCH	-0.3	7		
	ILLUM_LSIDE_DRIVE	-0.3	7		
	ILLUM_HSIDE_DRIVE	-2	28		
	ILLUM_A_BOOST vs ILLUM_HSIDE_DRIVE	-0.3	7		
	ILLUM_A,B_SW	-2	22		
	ILLUM_A,B_SW (10-ns transient)	-3	27	1	
	PWR_VIN, PWR1,2,3,4,5,6,7_VIN, VINA, ILLUM_VIN, ILLUM_A,B_VIN, DRST_VIN	-0.3	22		
	PWR1,2,5,6,7_BOOST	-0.3	28		
	PWR1,2,5,6,7_BOOST (10 ns transient)	-0.3	30	1	
	PWR1,2,5,6,7_SWITCH	-2	22		
	PWR1,2,5,6,7_SWITCH (10 ns transient)	-3	27		
	PWR1,2,5,6,7_FB	-0.3	6.5	1	
	PWR1,2,5,6,7_BOOST vs PWR1,2,5,6,7_SWITCH	-0.3	6.5		
oltage	CH1,2,3_SWITCH, DRST_LS_IND, ILLUM_A,B_FB	-0.3	20		
3	ILLUM_A,B_COMP1,2, INT_Z, PROJ_ON	-0.3	7		
	DRST_HS_IND	-18	7		
	ACMPR_IN_1,2,3, ACMPR_REF, ACMPR_IN_LABB, ACMPR_LABB_SAMPLE, ACMPR_OUT	-0.3	3.6		
	SPI_VIN, SPI_CLK, SPI_MOSI, SPI_SS_Z, SPI_MISO, CH_SEL_0,1, RESET_Z	-0.3	3.6		
	RLIM_K_1,2, RLIM_1,2	-0.3	3.6		
	DGND, AGND, DRST_PGND, ILLUM_A,B_PGND, PWR1,2,5,6,7_PGND, RLIM_BOT_K_1,2	-0.3	0.3		
	DRST_5P5V, ILLUM_5P5V, PWR_5P5, PWR3,4_OUT, SUP_5P0V	-0.3	7		
	CH1,2,3_GATE_CTRL	-0.3	7		
	CLK_OUT	-0.3	3.6		
	CW_SPEED_PWM	-0.3	7		
	SUP_2P5V	-0.3	3.6		
	DMD_VOFFSET	-0.3	12		
	DMD_VBIAS	-0.3	20	7	
	DMD_VRESET	-18	7		
011800 011	RESET_Z, ACMPR_OUT		1	ν Λ	
ource current	SPI_DOUT		5.5	– mA	
into accompany	RESET_Z, ACMPR_OUT		1	A	
Sink current	SPI_DOUT, INT_Z		5.5	mA	
stg	Storage temperature	-65	150	°C	

<sup>(1)</sup> Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute Maximum Ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.



## 6.2 ESD Ratings

			VALUE	UNIT
V (1)	Electrostatic	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins <sup>(2)</sup>	±2000	V
V <sub>(ESD)</sub> (1)	discharge	Charged device model (CDM), per JEDEC specification JESD22-C101, all pins <sup>(3)</sup>	±500	

- (1) Electrostatic discharge (ESD) to measure device sensitivity and immunity to damage caused by assembly line electrostatic discharges in to the device.
- (2) JEDEC document JEP155 states that 500 V HBM allows safe manufacturing with a standard ESD control process.
- (3) JEDEC document JEP157 states that 250 V CDM allows safe manufacturing with a standard ESD control process.

## **6.3 Recommended Operating Conditions**

Over operating free-air temperature range (unless otherwise noted)

		MIN	MAX	UNIT
	PWR_VIN, PWR1,2,3,4,5,6,7_VIN, VINA, ILLUM_VIN, ILLUM_A,B_VIN, DRST_VIN	6	20	
	CH1,2,3_SWITCH, ILLUM_A,B_FB	-0.1	20	
	PROJ_ON	-0.1	6	
	PWR1,2,5,6,7_FB	-0.1	5	5
nput voltage range	ACMPR_REF, CH_SEL_0,1, SPI_CLK, SPI_MOSI, SPI_SS_Z	-0.1	3.6	V
	RLIM_BOT_K_1,2	-0.1	0.1	
	ACMPR_IN_1,2,3, LABB_IN_LABB	-0.1	1.5	
	SPI_VIN	1.7	3.6	
	RLIM_K_1,2	-0.1	0.25	
	ILLUM_A,B_COMP1,2	-0.1	5.7	
Ambient temperature range		0	70	°C
Operating junction tem	perature	0	120	°C

### 6.4 Thermal Information

		DLPA3005		
	THERMAL METRIC <sup>(1)</sup>	PFD (HTQFP)	UNIT	
		100 PINS		
R <sub>θJA</sub>	Junction-to-ambient thermal resistance <sup>(2)</sup>	7.0	°C/W	
R <sub>0JC(top)</sub>	Junction-to-case (top) thermal resistance <sup>(3)</sup>	0.7	°C/W	
$R_{\theta JB}$	Junction-to-board thermal resistance	N/A	°C/W	
ΨЈТ	Junction-to-top characterization parameter <sup>(4)</sup>	0.6	°C/W	
ΨЈВ	Junction-to-board characterization parameter <sup>(5)</sup>	3.4	°C/W	
R <sub>θJC(bot)</sub>	Junction-to-case (bottom) thermal resistance	N/A	°C/W	

- (1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics Application Report.
- (2) The junction-to-ambient thermal resistance under natural convection is obtained in a simulation on a JEDEC-standard, high-K board, but since the device is intended to be cooled with a heatsink from the top case of the package, the simulation includes a fan and heatsink attached to the DLPA3005. The heatsink is a 22 mm × 22 mm × 12 mm aluminum pin fin heatsink with a 12 × 12 × 3 mm stud. Base thickness is 2 mm and pin diameter is 1.5 mm with an array of 6 × 6 pins. The heatsink is attached to the DLPA3005 with 100 um thick thermal grease with 3 W/m-K thermal conductivity. The fan is 20 × 20 × 8 mm with 1.6 cfm open volume flow rate and 0.22 in. water pressure at stagnation.
- (3) The junction-to-case (top) thermal resistance is obtained by simulating a cold plate test on the package top. No specific JEDEC standard test exists, but a close description can be found in the ANSI SEMI standard G30-88.
- (4) The junction-to-top characterization parameter, ψ<sub>JT</sub>, estimates the junction temperature of a device in a real system and is extracted from the simulation data for obtaining R<sub>θJA</sub>, using a procedure described in JESD51-2a (sections 6 and 7), but modified to include the fan and heatsink described in note 2.
- (5) The junction-to-board characterization parameter, ψ<sub>JB</sub>, estimates the junction temperature of a device in a real system and is extracted from the simulation data for obtaining R<sub>θ,JA</sub>, using a procedure described in JESD51-2a (sections 6 and 7), but modified to include the fan and heatsink described in note 2.

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## 6.5 Electrical Characteristics

Over operating free-air temperature range.  $V_{IN}$  = 12 V,  $T_A$  = 0 to +70°C, typical values are at  $T_A$  = 25°C, Configuration according to Section 8.2 ( $V_{IN}$  =12 V,  $I_{OUT}$  = 16 A, LED, external FETs) (unless otherwise noted).

	PARAMETER	= 16 A, LED, external FETs) (unless otherwise r TEST CONDITIONS	MIN	TYP	MAX	UNIT
		SUPPLIES				
INPUT VOLTA	AGE					
V <sub>IN</sub>	Input voltage range	VINA – pin	6 <sup>(6)</sup>	12	20	V
V <sub>UVLO</sub> (7)	UVLO threshold	VINA falling (through a 5-bit trim function, 0.5-V steps)	3.9	6.22	18.4	V
	Hysteresis	VINA rising		90		mV
V <sub>STARTUP</sub>	Startup voltage	DMD_VBIAS, DMD_VOFFSET, DMD_VRESET loaded with 10 mA			V	
INPUT CURR	ENT				,	
I <sub>IDLE</sub>	Idle current	IDLE mode, all VIN pins combined		15		μA
I <sub>STD</sub>	Standby current	STANDBY mode, analog, internal supplies and LDOs enabled, DMD, ILLUMINATION and BUCK CONVERTERS disabled.		3.7		mA
I <sub>Q_DMD</sub>	Quiescent current (DMD)	Quiescent current DMD block (in addition to I <sub>STD</sub> ), VINA + DRST_VIN		0.49		mA
I <sub>Q_ILLUM</sub>	Quiescent current (ILLUM)	Quiescent current ILLUM block (in addition to I <sub>STD</sub> ), V_openloop= 3 V (ILLUM_OLV_SEL), VINA + ILLUM_VIN + ILLUM_A_VIN + ILLUM_B_VIN	21			mA
I <sub>Q виск</sub>	Quiescent current (per BUCK)	Quiescent current per BUCK converter (in addition to I <sub>STD</sub> ), Normal mode, VINA + PWR_VIN + PWR1,2,5,6,7_VIN, PWR1,2,5,6,7_VOUT = 1 V		4.3		
		Quiescent current per BUCK converter (in addition to I <sub>STD</sub> ), Normal mode, VINA + PWR_VIN + PWR1,2,5,6,7_VIN, PWR1,2,5,6,7_VOUT = 5 V		15		mA
		Quiescent current per BUCK converter (in addition to I <sub>STD</sub> ), Cycle-skipping mode, VINA + PWR_VIN + PWR1,2,5,6,7_VIN = 1 V		0.41		
		Quiescent current per BUCK converter (in addition to I <sub>STD</sub> ), Cycle-skipping mode, VINA + PWR_VIN + PWR1,2,5,6,7_VIN = 5 V		0.46		
I <sub>Q_TOTAL</sub>	Quiescent current (Total)	Typical Application: ACTIVE mode, all VIN pins combined, DMD, ILLUMINATION and PWR1,2 enabled, PWR3,4,5,6,7 disabled.		38		mA
INTERNAL SI	JPPLIES					
V <sub>SUP_5P0V</sub>	Internal supply, analog			5		V
V <sub>SUP_2P5V</sub>	Internal supply, logic			2.5		V
		DMD—LDO DMD				
V <sub>DRST_VIN</sub>			6	12	20	V
V <sub>DRST_5P5V</sub>				5.5		V
PGOOD	Power good DRST 5P5V	Rising		80%		
1 GOOD	Lower 9000 DK31_3P3V	Falling		60%		
OVP	Overvoltage protection DRST_5P5V			7.2		V
	Regulator dropout	At 25 mA, VDRST_VIN= 5.5 V		56		mV
	Regulator current limit <sup>(2)</sup>		300	340	400	mA
		DMD—REGULATOR				



Over operating free-air temperature range.  $V_{IN}$  = 12 V,  $T_A$  = 0 to +70°C, typical values are at  $T_A$  = 25°C, Configuration according to Section 8.2 ( $V_{IN}$  =12 V,  $I_{OLIT}$  = 16 A, LED, external FETs) (unless otherwise noted).

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
_		Switch A (from DRST_5P5V to DRST_HS_IND)		920		
R <sub>DS(ON)</sub>	MOSFET ON-resistance	Switch B (from DRST_LS_IND to DRST_PGND)		450		mΩ
<b>.</b>	Forward valtage drep	Switch C (from DRST_LS_IND to DRST_VBIAS <sup>(1)</sup> ), VDRST_LS_IND = 2 V, I <sub>F</sub> = 100 mA		1.21		V
V <sub>FW</sub>	Forward voltage drop	Switch D (from DRST_LS_IND to DRST_VOFFSET <sup>(1)</sup> ), VDRST_LS_IND = 2 V, I <sub>F</sub> = 100 mA		1.22		V
t <sub>DIS</sub>	Rail Discharge time	C <sub>OUT</sub> = 1 μF			40	μs
t <sub>PG</sub>	Power-good timeout	Not tested in production		15		ms
I <sub>LIMIT</sub>	Switch current limit			610		mA
VOFFSET R	EGULATOR					
V <sub>OFFSET</sub>	Output voltage			10		V
	DC output voltage accuracy	I <sub>OUT</sub> = 10 mA	-0.3		0.3	V
	DC Load regulation	I <sub>OUT</sub> = 0 mA to 10 mA		-10		V/A
	DC Line regulation	I <sub>OUT</sub> = 10 mA, DRST_VIN = 8 V to 20 V		-5		mV/V
V <sub>RIPPLE</sub>	Output ripple	I <sub>OUT</sub> = 10 mA, C <sub>OUT</sub> = 1 μF		200		mVpp
I <sub>OUT</sub>	Output current		0.1		10	mA
	Power-good threshold	VOFFSET rising		86%		
PGOOD	(fraction of nominal output voltage)	VOFFSET falling		66%		
С	Output capacitor	Recommended value <sup>(5)</sup> (use same value as output capacitor on VRESET)	1			μF
		t <sub>DISCHARGE</sub> <40 μs at VIN = 8 V			1	
VBIAS REG	ULATOR					
V <sub>BIAS</sub>	Output voltage			18		V
	DC output voltage accuracy	I <sub>OUT</sub> = 10 mA	-0.3	,	0.3	V
	DC Load regulation	I <sub>OUT</sub> = 0 to 10 mA		-18		V/A
	DC Line regulation	I <sub>OUT</sub> = 10 mA, DRST_VIN = 8 V to 20 V		-3		mV/V
V <sub>RIPPLE</sub>	Output ripple	I <sub>OUT</sub> = 10 mA, C <sub>OUT</sub> = 470 nF		200		mVpp
I <sub>OUT</sub>	Output current		0.1		10	mA
	Power-good threshold	VBIAS rising		86%		
PGOOD	(fraction of nominal output voltage)	VBIAS falling		66%		
С	Output capacitor	Recommended value <sup>(5)</sup> (use same or smaller value as output capacitors VOFFSET / VRESET)	470			nF
		t <sub>DISCHARGE</sub> <40 μs at VIN = 8 V	-		470	
VRESET RE	GULATOR	1				·
V <sub>RST</sub>	Output voltage			-14		V
	DC output voltage accuracy	I <sub>OUT</sub> = 10 mA	-0.3		0.3	V
	DC Load regulation	I <sub>OUT</sub> = 0 to 10 mA		-4		V/A
	DC Line regulation	I <sub>OUT</sub> = 10 mA, DRST_VIN = 8 to 20 V		-2		mV/V
		_				
V <sub>RIPPLE</sub>	Output ripple	$I_{OUT}$ = 10 mA, $C_{OUT}$ = 1 $\mu$ F		120		mVpp
V <sub>RIPPLE</sub>	Output ripple Output current	$I_{OUT}$ = 10 mA, $C_{OUT}$ = 1 $\mu$ F	0.1	120	10	mVpp mA



Over operating free-air temperature range.  $V_{IN}$  = 12 V,  $T_A$  = 0 to +70°C, typical values are at  $T_A$  = 25°C, Configuration according to Section 8.2 ( $V_{IN}$  =12 V,  $I_{OUT}$  = 16 A, LED, external FETs) (unless otherwise noted).

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
С	Output capacitor	Recommended value <sup>(5)</sup> (use same value as output capacitor on VOFFSET)	1			μF
		t <sub>DISCHARGE</sub> <40 µs at VIN = 8 V			1	
		DMD - BUCK CONVERTERS			<u>'</u>	
OUTPUT VOLT	<b>TAGE</b>					
V <sub>PWR_1_VOUT</sub>	Output Voltage			1.1		V
V <sub>PWR_2_VOUT</sub>	Output Voltage			1.8		V
	DC output voltage accuracy	I <sub>OUT</sub> = 0 mA	-3%		3%	
MOSFET						
R <sub>ON,H</sub>	High side switch resistance	25°C, V <sub>PWR_1,2_Boost</sub> – V <sub>PWR1,2_SWITCH</sub> = 5.5 V		150		mΩ
R <sub>ON,L</sub>	Low side switch resistance <sup>(2)</sup>	25°C		85		mΩ
LOAD CURRE	NT				I	
	Allowed Load Current <sup>(3)</sup> .				3	Α
I <sub>OCL</sub>	Current limit <sup>(2)</sup>	L <sub>OUT</sub> = 3.3 μH	3.2	3.6	4.2	Α
ON-TIME TIME	R CONTROL	1				
t <sub>ON</sub>	On time	V <sub>IN</sub> = 12 V, V <sub>O</sub> = 5 V		120		ns
t <sub>OFF(MIN)</sub>	Minimum off time <sup>(2)</sup>	T <sub>A</sub> = 25°C, V <sub>FB</sub> = 0 V		270		ns
START-UP						
	Soft start		1	2.5	4	ms
PGOOD						
Ratio <sub>OV</sub>	Overvoltage protection			120%		
Ratio <sub>PG</sub>	Relative power good level	Low to high		72%		
		ILLUMINATION—LDO ILLUM				
V <sub>ILLUM_VIN</sub>			6	12	20	V
V <sub>ILLUM_5P5V</sub>				5.5		V
		Rising		80%		
PGOOD	Power good ILLUM_5P5V	Falling		60%		
OVP	Overvoltage protection ILLUM 5P5V			7.2		V
	Regulator dropout	At 25 mA, V <sub>ILLUM VIN</sub> = 5.5 V		53		mV
	Regulator current limit <sup>(2)</sup>		300	340	400	mA
		ILLUMINATION—DRIVER A,B				
V <sub>ILLUM_A,B_IN</sub>	Input supply voltage range		6	12	20	V
PWM						
$f_{\sf SW}$	Oscillator frequency	3 V < V <sub>IN</sub> < 20 V		600		kHz
3 0 11		HDRV off to LDRV on, TRDLY = 0		28		
t <sub>DEAD</sub>	Output driver dead time	HDRV off to LDRV on, TRDLY = 1		40		ns
DEAD	- 1	LDRV off to HDRV on, TRDLY = 0		35		
OUTPUT DRIV	ZERS					
R <sub>HDHI</sub>	High-side driver pull-up resistance	V <sub>ILLUM_A,B_BOOT</sub> - V <sub>ILLUM_A,B_SW</sub> = 5 V, I <sub>HDRV</sub> = -100 mA		4.9		Ω
R <sub>HDLO</sub>	High-side driver pull-down resistance	V <sub>ILLUM_A,B_BOOT</sub> - V <sub>ILLUM_A,B_SW</sub> = 5 V, I <sub>HDRV</sub> = 100 mÅ		3		Ω
R <sub>LDHI</sub>	Low-side driver pull-up resistance	I <sub>LDRV</sub> = -100 mA		3.1		Ω



Over operating free-air temperature range.  $V_{IN}$  = 12 V,  $T_A$  = 0 to +70°C, typical values are at  $T_A$  = 25°C, Configuration according to Section 8.2 ( $V_{IN}$  =12 V,  $I_{OUT}$  = 16 A, LED, external FETs) (unless otherwise noted).

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
R <sub>LDLO</sub>	Low-side driver pull-down resistance	I <sub>LDRV</sub> = 100 mA		2.4		Ω
t <sub>HRISE</sub>	High-side driver rise time <sup>(2)</sup>	C <sub>LOAD</sub> = 5 nF		23		ns
t <sub>HFALL</sub>	High-side driver fall time(2)	C <sub>LOAD</sub> = 5 nF		19		ns
t <sub>LRISE</sub>	Low-side driver rise time(2)	C <sub>LOAD</sub> = 5 nF		23		ns
t <sub>LFALL</sub>	Low-side driver fall time <sup>(2)</sup>	C <sub>LOAD</sub> = 5 nF		17		ns
OVERCURRENT	PROTECTION				'	
HSD OC	High-Side Drive Over Current threshold	External switches, V <sub>DS</sub> threshold <sup>(2)</sup>		185		mV
BOOT DIODE						
$V_{DFWD}$	Bootstrap diode forward voltage	I <sub>BOOT</sub> = 5 mA		0.75		V
PGOOD						
RatioUV	Undervoltage protection			89%		
DRIVERS EXTE	RNAL RGB STROBE CONTRO	DLLER SWITCHES				
CHx GATE CN	Outs control birth lovel	ILLUM_SW_ILIM_EN[2:0] = 7, register 0x02, I <sub>SINK</sub> = 400 μA		4.35		
TR_HIGH	Gate control high level	ILLUM_SW_ILIM_EN[2:0] = 0, register 0x02, I <sub>SINK</sub> = 400 μA		5.25		V
CHx_GATE_CN TR_LOW	Gate control low level	ILLUM_SW_ILIM_EN[2:0] = 7, register 0x02, I <sub>SINK</sub> = 400 μA		55		\/
		ILLUM_SW_ILIM_EN[2:0] = 0, register 0x02, I <sub>SINK</sub> = 400 μA		55		mV
LED CURRENT	CONTROL			-		
V <sub>LED_ANODE</sub>	LED Anode voltage <sup>(2)</sup>	Ratio with respect to V <sub>ILLUM_A,B_VIN</sub> (Duty cycle limitation).	0.85x			
_					15.5	V
I <sub>LED</sub>	LED currents	V <sub>ILLUM_A,B_VIN</sub> ≥ 8 V. See register SWx_IDAC[9:0] for settings.	1		16 <sup>(9)</sup>	Α
	DC current offset, CH1,2,3_SWITCH	R <sub>LIM</sub> = 12.5 mΩ	-150	0	150	mA
	Transient LED current limit	20% higher than $I_{LED}$ . Min-setting, $R_{LIM}$ = 12.5 m $\Omega$		11%		
	range (programmable)	20% higher than I <sub>LED</sub> . Max-setting, R <sub>LIM</sub> = 12.5 mΩ. Percentage of max current		133%		
t <sub>RISE</sub>	Current rise time	I <sub>LED</sub> from 5% to 95%, I <sub>LED</sub> = 600 mA, transient current limit disabled <sup>(2)</sup>			50	μs
		BUCK CONVERTERS—LDO_BUCKS				
V <sub>PWR_VIN</sub>	Input voltage range PWR1,2,5,6,7_VIN		6	12	20	٧
V <sub>PWR_5P5V</sub>	PWR_5P5V			5.5		V
	Dower good DMD CDCV	Rising		80%		
PGOOD	Power good PWR_5P5V	Falling		60%		
OVP	Overvoltage Protection PWR_5P5V			7.2		V
	Regulator dropout	At 25 mA, V <sub>PWR_VIN</sub> = 5.5 V		41		mV
	Regulator current limit <sup>(2)</sup>		300	340	400	mA
		ERTER - GENERAL PURPOSE BUCK CONVE		J+0	400	''



Over operating free-air temperature range.  $V_{IN}$  = 12 V,  $T_A$  = 0 to +70°C, typical values are at  $T_A$  = 25°C, Configuration according to Section 8.2 ( $V_{IN}$  =12 V,  $I_{OLIT}$  = 16 A, LED, external FETs) (unless otherwise noted).

,	PARAMETER	16 A, LED, external FETs) (unless otherwise TEST CONDITIONS	MIN	TYP	MAX	UNIT
OUTPUT VOLTA		1201 CONDITIONS			1011 (5)	<b>O</b> 1111
OUTFUT VOLI						
V <sub>PWR_6_VOUT</sub>	Output Voltage (General Purpose Buck2)	8-bit programmable	1		5	V
	DC output voltage accuracy	I <sub>OUT</sub> = 0 mA	-3.5%		3.5%	
MOSFET						
R <sub>ON,H</sub>	High side switch resistance	25°C, V <sub>PWR6_Boost</sub> – V <sub>PWR6_SWITCH</sub> = 5.5 V		150		mΩ
R <sub>ON,L</sub>	Low side switch resistance <sup>(2)</sup>	25°C		85		mΩ
LOAD CURRENT						
	Allowed Load Current PWR6 <sup>(3)</sup> .			2		Α
I <sub>OCL</sub>	Current limit <sup>(2)</sup> (3)	L <sub>OUT</sub> = 3.3 μH	3.2	3.6	4.2	Α
ON-TIME TIMER CONTROL						
t <sub>ON</sub>	On time	V <sub>IN</sub> = 12 V, V <sub>O</sub> = 5 V		120		ns
t <sub>OFF(MIN)</sub>	Minimum off time <sup>(2)</sup>	T <sub>A</sub> = 25°C, V <sub>FB</sub> = 0 V		270	310	ns
START-UP						
	Soft start		1	2.5	4	ms
PGOOD						
Ratio <sub>OV</sub>	Overvoltage protection			120%		
Ratio <sub>PG</sub>	Relative power good level	Low to high		72%		
		AUXILIARY LDOs				
V <sub>PWR3,4_VIN</sub>	Input voltage range	LDO1 (PWR4), LDO2 (PWR3)	3.3	12	20	V
PGOOD	Power good PWR3,4_VOUT	PWR3,4_VOUT rising		80%		
		PWR3,4_VOUT falling		60%		
OVP	Overvoltage Protection PWR3,4_VOUT			7		٧
	DC output voltage accuracy PWR3,4_VOUT	I <sub>OUT</sub> = 0 mA	-3%		3%	
	Regulator current limit <sup>(2)</sup>		300	340	400	mA
t <sub>ON</sub>	Turn-on time	to 80% of V <sub>OUT</sub> = PWR3 and PWR4, C= 1 μF		40		μs
LDO2 (PWR3)						
V <sub>PWR3_VOUT</sub>	Output Voltage PWR3_VOUT			2.5		V
	Load Current capability			200		mA
	DC Load regulation PWR3_VOUT	V <sub>OUT</sub> = 2.5 V, I <sub>OUT</sub> = 5 to 200 mA		-70		mV/A
	DC Line regulation PWR3_VOUT	V <sub>OUT</sub> = 2.5 V, I <sub>OUT</sub> = 5 mA, PWR3_VIN = 3.3 to 20 V		30		μV/V
LDO1 (PWR4)						
V <sub>PWR4_VOUT</sub>	Output Voltage PWR4_VOUT			3.3		V
	Load Current capability			200		mA
	DC Load regulation PWR4_VOUT	V <sub>OUT</sub> = 3.3 V, I <sub>OUT</sub> = 5 to 200 mA		-70		mV/A
	DC Line regulation PWR4_VOUT	V <sub>OUT</sub> = 3.3V, I <sub>OUT</sub> = 5 mA, PWR4_VIN= 4 to 20 V		30		μV/V
	Regulator dropout	At 25 mA, V <sub>OUT</sub> = 3.3 V, V <sub>PWR4 VIN</sub> = 3.3 V		48		mV
	•	1 1114-111				



Over operating free-air temperature range.  $V_{IN}$  = 12 V,  $T_A$  = 0 to +70°C, typical values are at  $T_A$  = 25°C, Configuration according to Section 8.2 ( $V_{IN}$  =12 V,  $I_{OUT}$  = 16 A, LED, external FETs) (unless otherwise noted).

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
		MEASUREMENT SYSTEM				
LABB						
	0 1111 11	To 1% of final value <sup>(2)</sup>		4.6	6.6	
T <sub>RC</sub>	Settling time	To 0.1% of final value <sup>(2)</sup>	,	7	10	μs
V <sub>ACMPR_IN_LABB</sub>	Input voltage range ACMPR_IN_LABB		0		1.5	V
	Sampling window ACMPR_IN_LABB	Programmable per 7 μs	7		28	μs
	DIGITAL CON	ITROL - LOGIC LEVELS AND TIMING CHARACT	ERISTICS	· · · · · · · · · · · · · · · · · · ·		
V <sub>SPI_VIN</sub>	SPI supply voltage range	SPI_VIN	1.7		3.6	V
V <sub>OL</sub>		RESET_Z, ACMPR_OUT, CLK_OUT. I <sub>O</sub> = 0.3 mA sink current	0		0.3	
	Output low-level	SPI_DOUT. I <sub>O</sub> = 5 mA sink current	0	,	0.3 × V <sub>SPI_VIN</sub>	V
		INT_Z. I <sub>O</sub> = 1.5 mA sink current	0	,	0.3 × V <sub>SPI_VIN</sub>	
$V_OH$	Output high-level	RESET_Z, ACMPR_OUT, CLK_OUT. I <sub>O</sub> = 0.3 mA source current	1.3		2.5	V
		SPI_DOUT. I <sub>O</sub> = 5 mA source current	0.7 × V <sub>SPI_VIN</sub>	,	V <sub>SPI_VIN</sub>	V
V <sub>IL</sub>	Input low-level	PROJ_ON, CH_SEL_0, CH_SEL_1	0		0.4	
		SPI_CSZ, SPI_CLK, SPI_DIN	0	,	0.3 × V <sub>SPI_VIN</sub>	V
	Input high-level	PROJ_ON, CH_SEL_0, CH_SEL_1	1.2			
V <sub>IH</sub>		SPI_CSZ, SPI_CLK, SPI_DIN	0.7 × V <sub>SPI_VIN</sub>	,	V <sub>SPI_VIN</sub>	V
BIAS	Input bias current	V <sub>IO</sub> = 3.3 V, any digital input pin			0.1	μΑ
SPI_CLK	SPI clock frequency <sup>(4)</sup>	Normal SPI mode, DIG_SPI_FAST_SEL = 0, $f_{OSC}$ = 9 MHz	0		36	MHz
or i_oek		Fast SPI mode, DIG_SPI_FAST_SEL = 1, $V_{SPI\_VIN}$ > 2.3 V, $f_{OSC}$ = 9 MHz	20		40	IVII IZ
DEGLITCH	Deglitch time	CH_SEL_0, CH_SEL_1 <sup>(2)</sup>	'	300		ns
		INTERNAL OSCILLATOR				
fosc	Oscillator frequency			9		MHz
	Frequency accuracy	T <sub>A</sub> = 0 °C to 70°C	-5%		5%	
		THERMAL SHUTDOWN				
T <sub>WARN</sub>	Thermal warning (HOT threshold)			120		°C
	Hysteresis			10		
T <sub>SHTDWN</sub>	Thermal shutdown (TSD threshold)			150		°C
· SUIDWN	Hysteresis			15		

- Including rectifying diode (1)
- (2) Not production tested
- (3) Care should be taken not to exceed the max power dissipation. Refer to Section 10.3.
- Maximum depends linearly on oscillator frequency f<sub>OSC</sub>. (4)
- Take care that the capacitor has the specified capacitance at the related voltage, that is,  $V_{OFFSET}$ ,  $V_{BIAS}$ , or  $V_{RESET}$ . VIN must be higher than the UVLO voltage setting, including after accounting for AC noise on VIN, for the DLPA3005 to fully operate. While 6.0 V is the min VIN voltage supported, TI recommends that the UVLO is never set below 6.21 V for fault fast power down.

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6.21 V gives margin above 6.0 V to protect against the case where someone suddenly removes VIN's power supply which causes the VIN voltage to drop rapidly. Failure to keep VIN above 6.0V before the mirrors are parked and VOFS, VRST, and VBIAS supplies are properly shut down can result in permanent damage to the DMD. Since 6.21 V is .21 V above 6.0 V, when UVLO trips there is time for the DLPA3005 and DLPC343x to park the DMD mirrors and do a fast shut down of supplies VOFS, VRST, and VBIAS. For whatever UVLO setting is used, if VIN's power supply is suddenly removed enough bulk capacitance should be included on VIN inside the projector to keep VIN above 6.0V for at least 100us after UVLO trips.

- (7) UVLO should not be used for normal power down operation, it is meant as a protection from power loss.
- (8) General purpose buck2 (PWR6) is currently supported.
- (9) Supports up to 32 A for series LEDs based on reference hardware design.

## **6.6 SPI Timing Parameters**

SPI\_VIN = 3.6 V  $\pm$  5%, T<sub>A</sub> = 0 to 70°C, C<sub>L</sub> = 10 pF (unless otherwise noted).

		MIN	NOM MAX	UNIT
f <sub>CLK</sub>	Serial clock frequency	0	40	MHz
t <sub>CLKL</sub>	Pulse width low, SPI_CLK, 50% level	10		ns
t <sub>CLKH</sub>	Pulse width high, SPI_CLK, 50% level	10		ns
t <sub>t</sub>	Transition time, 20% to 80% level, all signals	0.2	4	ns
t <sub>CSCR</sub>	SPI_SS_Z falling to SPI_CLK rising, 50% level	8		ns
t <sub>CFCS</sub>	SPI_CLK falling to SPI_CSZ rising, 50% level		1	ns
t <sub>CDS</sub>	SPI_MOSI data setup time, 50% level	7		ns
t <sub>CDH</sub>	SPI_MOSI data hold time, 50% level	6		ns
t <sub>iS</sub>	SPI_MISO data setup time, 50% level	10		ns
t <sub>iH</sub>	SPI_MISO data hold time, 50% level	0		ns
t <sub>CFDO</sub>	SPI_CLK falling to SPI_MISO data valid, 50% level		13	ns
t <sub>CSZ</sub>	SPI_CSZ rising to SPI_MISO HiZ		6	ns

Product Folder Links: DLPA3005

## 7 Detailed Description

### 7.1 Overview

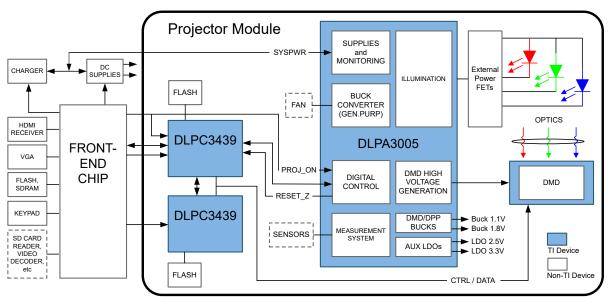
The DLPA3005 is a highly integrated power management IC optimized for DLP Pico Projector systems. It targets accessory applications up to several hundreds of lumen and is designed to support a wide variety of high-current LEDs. Section 7.2 shows a typical DLP Pico Projector implementation using the DLPA3005.

Part of the projector is the projector module, which is an optimized combination of components consisting of, for instance, DLPA3005, LEDs, DMD, DLPC chip, memory, and optional sensors and fan. The front-end chip controls the projector module. More information about the system and projector module configuration can be found in a separate application note.

Within the DLPA3005, several blocks can be distinguished. The blocks are listed below and subsequently discussed in detail:

- Supply and monitoring: Creates internal supply and reference voltages and has functions such as thermal protection
- Illumination: Block to control the light. Contains drivers, strobe decoder for the LEDs and power conversion
- · External Power FETs: Capable for 16 A
- DMD: Generates voltages and their specific timing for the DMD. Contains regulators and DMD/DLPC buck converters
- Buck converter: General purpose buck converter
- Auxiliary LDOs: Fixed voltage LDOs for customer usage
- · Measurement system: Analog front end to measure internal and external signals
- · Digital control: SPI interface, digital control

## 7.2 Functional Block Description





## 7.3 Feature Description

### 7.3.1 Supply and Monitoring

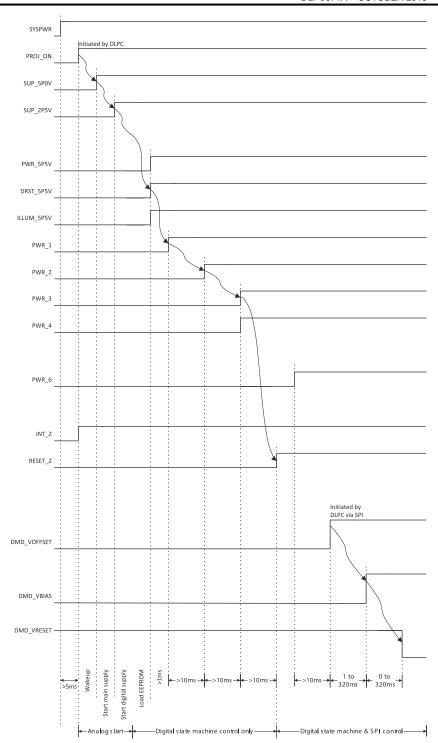
This block takes care of creating several internal supply voltages and monitors correct behavior of the device.

## 7.3.1.1 Supply

SYSPWR is the main supply of the DLPA3005. It can range from 6 V to 20 V, where the typical is 12 V. At power-up, several (internal) power supplies are started one after the other in order to make the system work correctly (Figure 7-1). A sequential startup ensures that all the different blocks start in a certain order and prevent excessive startup currents. The main control to start the DLPA3005 is the control pin  $PROJ_ON$ . Once set high the *basic* analog circuitry is started that is needed to operate the digital and SPI interface. This circuitry is supplied by two LDO regulators that generate 2.5 V (SUP\_2P5V) and 5 V (SUP\_5P0V). These regulator voltages are for internal use only and should not be loaded by an external application. The output capacitors of those LDOs should be 2.2  $\mu$ F for the 2.5-V LDO, and 4.7  $\mu$ F for the 5-V LDO, pin 91 and 92 respectively. Once these are up the digital core is started, and the DLPA3005 Digital State Machine (DSM) takes over.

Subsequently, the 5.5-V LDOs for various blocks are started: PWR\_5V5V, DRST\_5P5V and ILLUM\_5P5V. Next, the buck converters and DMD LDOs are started (PWR\_1 to PWR\_4). The DLPA3005 is now awake and ready to be controlled by the DLPC (indicated by RESET Z going high).

The general purpose buck converter (PWR\_6) can be started (if used) as well as the regulator that supplies the DMD. The DMD regulator generates the timing critical VOFFSET, VBIAS, and VRESET supplies.



- 1. Arrows indicate sequence of events automatically controlled by digital state machine. Other events are initiated under SPI control.
- 2. SUP\_5P0V and SUP\_2P5V rise to a precharge level with SYSPWR, and reach the full level potential after PROJ\_ON is pulled high.

Figure 7-1. Powerup Timing

## 7.3.1.2 Monitoring

Several possible faults are monitored by the DLPA3005. If a fault has occurred and what kind of fault it is can be read in Main Status register. Subsequently, an interrupt can be generated if such a fault occurs. The fault conditions for which an interrupt is generated can be configured individually in the Interrupt Mask register.



#### 7.3.1.2.1 Block Faults

Fault conditions for several supplies can be observed such as the low voltage supplies (SUPPLY\_FAULT). ILLUM\_FAULT monitors correct supply and voltage levels in the illumination block and DMD\_FAULT monitors a correct functioning DMD block. The PROJ\_ON\_INT bit indicates if PROJ\_ON was asserted.

### 7.3.1.2.2 Auto LED Turn Off Functionality

The DLPA3005 can be supplied from an adapter. The DLPA3005 use several warning and detection levels, as indicated in the previous paragraphs, to prevent system damage in case the supply voltage becomes too low or even interrupted.

Interruption of the supply voltage occurs when, for example, the adapter is switched to another mains outlet. A change of supply voltage from, for example, 20 V to 8 V can occur, and thus the OVP level (which is ratio metric, see Section 7.3.2.5.2) could become lower than  $V_{LED}$ . An OVP fault will be triggered and the system switches off.

The Auto\_LED\_Turn\_Off functionality can be used to prevent the system from turning off in these circumstances. This function disables the LEDs when the supply voltage drops below LED\_AUTO\_OFF\_LEVEL. When the Auto\_LED\_Turn\_Off functionality is enabled (reg 0x01h), once a supply voltage drop is detected to below LED\_AUTO\_OFF\_LEVEL, the LEDs will be switched off and the system should start sending lower current levels to have a lower  $V_{LED}$ . After start using lower currents, the LEDs can be switched on again by disabling AUTO\_LED\_TURN\_OFF function. As a result the system can continue working at the lower supply voltage using a lower intensity. Once the mains adapter is plugged in again, the Auto\_LED\_Turn\_Off functionality can be enabled again. Now the LED currents can be restored to their original levels from before the supply voltage drop.

#### 7.3.1.2.3 Thermal Protection

The chip temperature is monitored constantly to prevent overheating of the device. There are two levels of a fault condition. The first is TS\_WARN to warn for overheating. This is an indication that the chip temperature raises to a critical temperature. The next level of warning is TS\_SHUT. This occurs at a higher temperature than TS\_WARN and shuts down the chip to prevent permanent damage. Both temperature faults have hysteresis on their levels to prevent rapid switching around the temperature threshold.

#### 7.3.2 Illumination

The illumination function includes all blocks needed to generate light for the DLP system. In order to accurately set the current through the LEDs, a control loop is used (Figure 7-2). The intended LED current is set through IDAC[9:0]. The Illumination driver controls the LED anode voltage  $V_{LED}$  and as a result a current will flow through one of the LEDs. The LED current is measured from the voltage across sense resistor  $R_{LIM}$ . Based on the difference between the actual and intended current, the loop controls the output of the buck converter ( $V_{LED}$ ) higher or lower. The LED which conducts the current is controlled by switches P, Q, and R. The *Openloop feedback circuitry* ensures that the control loop can be closed for cases when there is no path through the LED (for instance, when  $I_{LED} = 0$ ).

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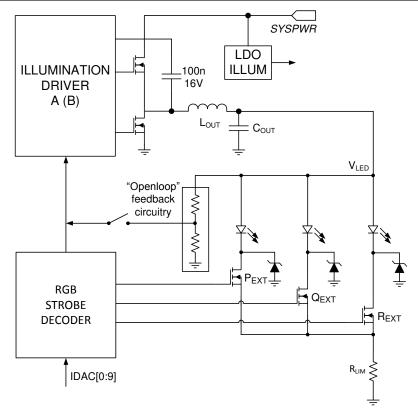


Figure 7-2. Illumination Control Loop

Within the illumination block, the following blocks can be distinguished:

- Programmable gain block
- · LDO ILLUM, analog supply voltage for internal illumination blocks
- Illumination driver A, primary driver for the external FETs
- Illumination driver B, secondary driver for future purpose. Will not be discussed
- RGB strobe decoder, driver for external switches to control the on-off rhythm of the LEDs and measures the LED current

## 7.3.2.1 Programmable Gain Block

The current through the LEDs is determined by a digital number stored in the respective SWx\_IDAC(x) registers, 0x03h to 0x08h. These registers determine the LED current which is measured through the sense resistor  $R_{LIM}$ . The voltage across  $R_{LIM}$  is compared with the current setting from the IDAC registers and the loop regulates the current to its set value.



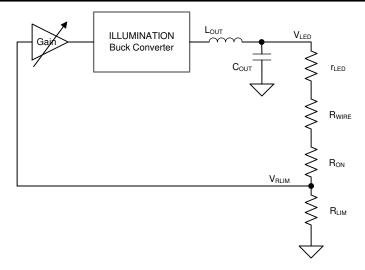


Figure 7-3. Programmable Gain Block in the Illumination Control Loop

When current is flowing through an LED, a forward voltage is built up over the LED. The LED also represents a (low) differential resistance which is part of the load circuit for  $V_{LED}$ . Together with the wire resistance ( $R_{WIRE}$ ) and the  $R_{ON}$  resistance of the FET switch a voltage divider is created with  $R_{LIM}$  that is a factor in the loop gain of the ILED control. Under normal conditions, the loop is able to produce a well regulated LED current up to 16 Amps.

Since this voltage divider is part of the control loop, care must be taken while designing the system.

When, for instance, two LEDs in series are connected, or when a relatively high wiring resistance is present in the loop, the loop gain will reduce due to the extra attenuation caused by the increased series resistances of  $r_{LED} + R_{WIRE} + R_{ON}$ . As a result, the loop response time lowers. To compensate for this increased attenuation, the loop gain can be increased by selecting a higher gain for the programmable gain block. The gain increase can be set through register ILLUM BW BCx.

Under normal circumstances the default gain setting (00h) is sufficient. In case of a series connection of two LEDs setting 01h or 02h might suffice.

As discussed previously, wiring resistance also impacts the control-loop performance. It is advisable to prevent unnecessary large wire length in the loop. Keeping wiring resistance as low as possible is good for efficiency reasons. In case wiring resistance still impacts the response time of the loop, an appropriate setting of the gain block can be selected. The same goes for connector resistance and PCB tracks. Note that every milliohm  $(m\Omega)$  counts. These precautions help to ensure the proper functioning of the  $I_{LED}$  current loop.

## 7.3.2.2 LDO Illumination

This regulator is dedicated to the illumination block and provides an analog supply of 5.5 V to the internal circuitry. It is recommended to use  $1-\mu F$  capacitors on both the input and output of the LDO.

#### 7.3.2.3 Illumination Driver A

The illumination driver of the DLPA3005 is a buck controller for driving two external low-ohmic N-channel FETs (Figure 7-4). The theory of operation of a buck converter is explained in the application note *Understanding Buck Power Stages in Switchmode Power Supplies*. For proper operation, selection of the external components is very important, especially the inductor  $L_{OUT}$  and the output capacitor  $C_{OUT}$ . For best efficiency and ripple performance, an inductor and capacitor should be chosen with low equivalent series resistance (ESR).

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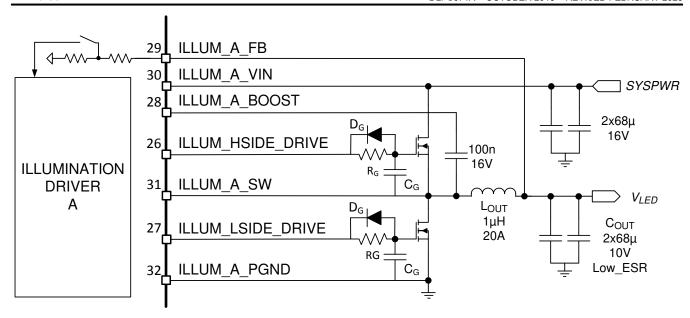


Figure 7-4. Typical Illumination Driver Configuration

Several factors determine the component selection of the buck converter, such as input voltage (SYSPWR), desired output voltage ( $V_{LED}$ ) and the allowed output current ripple. Configuration starts with selecting the inductor  $L_{OUT}$ .

The value of the inductance of a buck power stage is selected such that the peak-to-peak ripple current flowing in the inductor stays within a certain range. Here, the target is set to have an inductor current ripple,  $k_{I\_RIPPLE}$ , less than 0.3 (30%). The minimum inductor value can be calculated given the input and output voltage, output current, switching frequency of the buck converter ( $f_{SWITCH}$ = 600 kHz), and inductor ripple of 0.3 (30%):

$$L_{OUT} = \frac{\frac{V_{OUT}}{V_{IN}} \cdot (V_{IN} - V_{OUT})}{k_{I\_RIPPLE} \cdot l_{OUT} \cdot f_{SWITCH}}$$
(1)

Example:  $V_{IN}$ = 12 V,  $V_{OUT}$ = 4.3 V,  $I_{OUT}$ = 16 A results in an inductor value of  $L_{OUT}$ = 1  $\mu$ H

Once the inductor is selected, the output capacitor  $C_{OUT}$  can be determined. The value is calculated using the fact that the frequency compensation of the illumination loop has been designed for an LC-tank resonance frequency of 15 kHz:

$$f_{RES} = \frac{1}{2 \cdot \pi \cdot \sqrt{L_{OUT} \cdot C_{OUT}}} = 15kHz$$
 (2)

Example:  $C_{OUT}$ = 110  $\mu F$  given that  $L_{OUT}$ = 1  $\mu H$ . A practical value is 2 × 68  $\mu F$ . Here, a parallel connection of two capacitors is chosen to lower the ESR even further.

The selected inductor and capacitor determine the output voltage ripple. The resulting output voltage ripple  $V_{LED\_RIPPLE}$  is a function of the inductor ripple  $k_{I\_RIPPLE}$ , output current  $I_{OUT}$ , switching frequency  $f_{SWITCH}$  and the capacitor value  $C_{OUT}$ :

$$V_{LED\_RIPPLE} = \frac{k_{I\_RIPPLE} \cdot I_{OUT}}{8 \cdot f_{SWITCH} \cdot C_{OUT}}$$
(3)

Example:  $k_{I\_RIPPLE}$ = 0.3,  $I_{OUT}$ = 16 A,  $f_{SWITCH}$ = 600 kHz and  $C_{OUT}$ = 2 x 68  $\mu$ F results in an output voltage ripple of  $V_{LED\_RIPPLE}$ = 7 mVpp



As can be seen, this is a relatively small ripple.

It is strongly advised to keep the capacitance value low. The larger the capacitor value the more energy is stored. In case of a  $V_{LED}$  going down stored energy needs to be dissipated. This might result in a large discharge current. For a  $V_{LED}$  step down from  $V_1$  to  $V_2$ , while the LED current was  $I_1$ . The theoretical peak reverse current is:

$$I_{2,MAX} = \sqrt{\frac{C_{OUT}}{L_{OUT}} \times (V_1^2 - V_2^2) + I_1^2}$$
(4)

Depending on the selected external FETs, the following three components might need to be added for each power FET:

- Gate series resistor (R<sub>G</sub>)
- Gate series diode (D<sub>G</sub>)
- Gate parallel capacitance (C<sub>G</sub>)

It is advisable to have placeholders for these components in the board design.

The gate series resistors can be used to slow down the enable transient of the power FET. Since large currents are being switched, a fast transient implies a potential risk on ringing. Slowing down the turn-on transient reduces the edge steepness of the drain current and thus reduces the induced inductive ringing. A resistance of a few Ohm typically is sufficient.

The gate series resistance is also present in the turn-off transient of the power FET. This might have a negative effect on the non-overlap timing. In order to keep the turn-off transient of the power FET fast, a parallel diode with the gate series resistance can be used. The cathode of the diode should be directed to the DLPA3005 device in order have fast gate pull-down.

A third component that might be needed, depending on the specific configuration and FET selection, is an extra gate-source filter capacitance. Specifically, for the higher supply voltages this capacitance is advisable. Due to a large drain voltage swing and the drain-gate capacitance, the gate of a disabled power FET might be pulled high parasitically.

For the low-side FET this can happen at the end of the non-overlap time while the power converter is supplying current. For that case the switch node is low at the end of the non-overlap time. Enabling the high-side FET pulls high the switch node. Due to the large and steep switch node edge, charge is injected through the drain-gate capacitance of the low-side FET into the gate of the low-side FET. As a result the low-side FET can be enabled for a short period of time causing a shoot-through current.

For the high-side FET a dual case exists. If the power converter is discharging VLED, the power converter current is directed inward and thus at the end of the non-overlap time the switch node is high. If at that moment the low-side FET is enabled, via the gate-drain capacitance of the high-side FET charge is being injected into the gate of the high-side FET potentially causing the device to switch on for a short amount of time. That will cause a shoot through current as well.

To reduce the effect of the charge injection through the drain-gate capacitance, an extra gate-source filter capacitance can be used. Assuming a linear voltage division between gate-source capacitance and gate-drain capacitance, for a 20V supply voltage the ratio of gate-source capacitance and gate-drain capacitance should be kept to about 1:10 or larger. It is advised to carefully test the gate-drive signals and the switch node for potential cross conduction.

Sometimes dual FETs are used to spread out power dissipation (heat). To prevent parasitic gate-oscillation a structure, as shown in Figure 7-5 is suggested. Each gate is being isolated with  $R_{\rm ISO}$  to damp potential oscillations. A resistance of 1 Ohm is typically sufficient.

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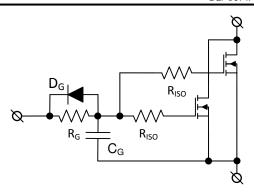


Figure 7-5. Using R<sub>ISO</sub> to Prevent Gate Oscillations When Using Power FETs in Parallel

Finally, two other components need to be selected in the buck converter. The value of the input-capacitor (pin ILLUM\_A\_VIN) should be equal or greater than the selected output capacitance  $C_{OUT}$ , in this case  $\geq 2 \times 68 \ \mu F$ . The capacitor between ILLUM\_A\_SWITCH and ILLUM\_A\_BOOST is a charge pump capacitor to drive the high side FET. The recommended value is 100 nF.

#### 7.3.2.4 RGB Strobe Decoder

The DLPA3005 contains circuitry to sequentially control the three color-LEDs (red, green, and blue). This circuitry consists of three drivers to control external switches, the actual strobe decoder, and the LED current control (Figure 7-6). The NMOS switches are connected to the cathode terminals of the external LED package and turn on and off the currents through the LEDs.

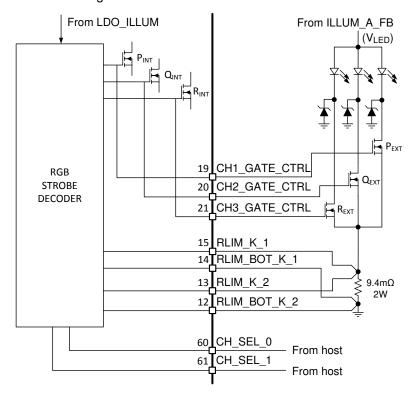


Figure 7-6. Switch Connection for a Common-Anode LED Assembly

The NMOS FETs P, Q, and R are controlled by the CH\_SEL\_0 and CH\_SEL\_1 pins. CH\_SEL[1:0] typically receive a rotating code switching from RED to GREEN to BLUE and then back to RED. The relation between CH\_SEL[0:1] and which switch is closed is indicated in Table 7-1.



Table 7-1	Switch	Positions	for Common	Anode	RGR I FDs
1 abic 1-1.	JWILLII	r usiliulis		Alluue	NGD LLDS

PINS CH SEL[1:0]		SWITCH		IDAC REGISTER
PING CH_SEL[1.0]	Р	Q	R	IDAC REGISTER
00	Open	Open	Open	N/A
01	Closed	Open	Open	0x03 and 0x04 SW1_IDAC[9:0]
10	Open	Closed	Open	0x05 and 0x06 SW2_IDAC[9:0]
11	Open	Open	Closed	0x07 and 0x08 SW3_IDAC[9:0]

Besides enabling one of the switches, CH\_SEL[1:0] also selects a 10-bit current setting for the control IDAC that is used as the set current for the LED. This set current together with the measured current through  $R_{LIM}$  is used to control the illumination driver to the appropriate  $V_{LED}$ . The current through the 3 LEDs can be set independently by registers SWx\_IDAC(x), 0x03 to 0x08 (Table 7-1).

Each current level can be set from off to 150 mV/R<sub>LIM</sub> in 1023 steps:

Led current(A) = 0 for bit value = 0

$$Led current(A) = \frac{Bit \ value \ +1}{1024} \cdot \frac{150 mV}{R_{LIM}} \text{ for bit value } = 1 \text{ to } 1023 \tag{5}$$

For single LED, the maximum current for  $R_{LIM}$ = 9.4 m $\Omega$  is thus 16A.

For two LEDs in series, the maximum current is 32A, thus  $R_{LIM}$  (for example,  $R_{LIM}$ = 4.7 m $\Omega$  to support configuration for 32A) need to change for higher LED current.

For proper operation a minimum LED current of 5% of  $I_{LED\ MAX}$  is required.

### 7.3.2.4.1 Break Before Make (BBM)

The switching of the three LED NMOS switches (P, Q, R) is controlled such that a switch is returned to the OPEN position first before the subsequent switch is set to the CLOSED position (BBM), Figure 7-7. The dead time between opening and closing switches is controlled through the BBM register. Switches that already are in the CLOSED position and are to remain in the CLOSED state, are not opened during the BBM delay time.

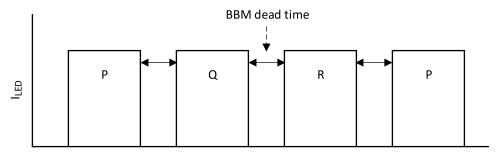


Figure 7-7. BBM Timing

### 7.3.2.4.2 Openloop Voltage

Several situations exist in which the control loop for the buck converter through the LED is not present. To prevent the output voltage of the buck converter to "run-away," the loop is closed by means of an internal resistive divider (see Figure 7-2—Openloop feedback circuitry). Situations in which the openloop voltage control is active:

- During the BBM period. Transitions from one LED to another implies that during the BBM time all LEDs are
  off.
- · Current setting for all three LEDs is 0.

It is advised to set the openloop voltage to about the lowest LED forward voltage. The openloop voltage can be set between 3 V and 18 V in steps of 1 V through register ILLUM\_OLV\_SEL.

#### 7.3.2.4.3 Transient Current Limit

Typically, the forward voltages of the GREEN and BLUE diodes are close to each other (about 3 V to 5 V) however the forward voltage of the red diode is significantly lower (2 V to 4 V). This can lead to a current spike in the RED diode when the strobe controller switches from green or blue to red. This happens because V<sub>LED</sub> is initially at a higher voltage than required to drive the red diode. DLPA3005 provides transient current limiting for each switch to limit the current in the LEDs during the transition. The transient current limit value is controlled through register 0x02 (ILLUM\_ILIM). In a typical application it is required only for the RED diode. The value for ILLUM\_ILIM should be set at least 20% higher than the DC regulation current. Register 0x02 (ILLUM\_SW\_ILIM\_EN) contains three bits to select which switch employs the transient current limiting feature. The effect of the transient current limit on the LED current is shown in Figure 7-8.

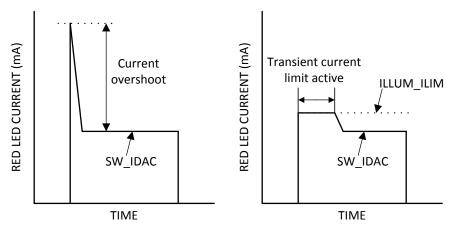


Figure 7-8. LED Current Without (Left) and With (Right) Transient Current Limit

### 7.3.2.5 Illumination Monitoring

The illumination block is continuously monitored for system failures to prevent damage to the DLPA3005 and LEDs. Several possible failures are monitored such as a broken control loop and a too high or too low output voltage V<sub>LED</sub>. The overall illumination fault bit is in Main Status register (ILLUM\_FAULT). If any of the below failures occur, the ILLUM FAULT bit may be set high:

- ILLUM BC1 PG FAULT
- ILLUM BC1 OV FAULT

Where, PG= Power Good and OV= Over Voltage

#### 7.3.2.5.1 Power Good

Both the Illumination driver and the Illumination LDO have a power good indication. The power good for the driver indicates if the output voltage ( $V_{LED}$ ) is within a defined window indicating that the LED current has reached the set point. If for some reason the LED current cannot be controlled to the intended value, this fault occurs. Subsequently, bit ILLUM\_BC1\_PG\_FAULT in the Detailed status register1 is set high. The illumination LDO output voltage is also monitored. When the power good of the LDO is asserted it implies that the LDO voltage is below a predefined minimum of 80% (rising) or 60% (falling) edge. The power good indication for the LDO is in the Detailed status register1.

#### 7.3.2.5.2 Ratio Metric Overvoltage Protection

The DLPA3005 illumination driver LED outputs are protected against open circuit use. In case no LED is connected and the DLPA3005 is instructed to set the LED current to a specific level, the LED voltage (ILLUM\_A\_FB) will quickly rise and potentially rail to VIN. This should be prevented. The OVP protection circuit triggers once  $V_{\text{LED}}$  crosses a predefined level. As a result, the DLPA3005 is switched off.

The same protection circuit is triggered in case the supply voltage (VINA) will become too low to have the DLPA3005 work properly given the  $V_{LED}$  level. This protection circuit is constructed around a comparator that will sense both the LED voltage and the VINA supply voltage. The fraction of the VINA is connected to the minus

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input of the comparator while the fraction of the  $V_{LED}$  voltage is connected to the plus input. Triggering occurs when the plus input rises above the minus input and an OVP fault is set. The fraction of the VINA must be set between 1 V and 4 V to ensure proper operation of the comparator.

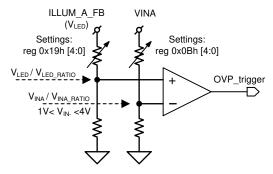


Figure 7-9. Ratio Metric OVP

The fraction of the ILLUM\_A\_FB voltage is set by the register VLED\_OVP\_VLED\_RATIO, while the setting of the fraction of the VINA voltage is done by register VLED\_OVP\_VIN\_RATIO. In general, an OVP fault is set when:

 $V_{LED}/V_{LED\_RATIO} \ge V_{INA}/V_{INA\_RATIO}$ 

thus when:

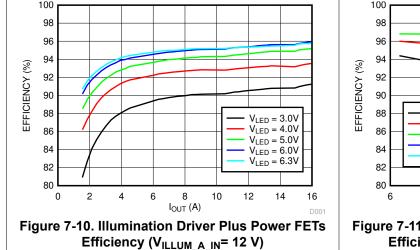
V<sub>LED</sub> ≥ V<sub>INA</sub> \* V<sub>LED</sub> <sub>RATIO</sub>/V<sub>INA</sub> <sub>RATIO</sub>.

Clearly, the OVP level is ratio-metric; that is, can be set to a fixed fraction of V<sub>INA</sub>.

### 7.3.2.6 Illumination Driver plus Power FETs Efficiency

Below (Figure 7-10) an overview is given of the efficiency of the illumination driver plus power FETs for an input voltage of 12 V. Used external components (Figure 7-4): High-side FET (L) CDS17506Q5A, Low-side FET (M) CDS17501Q5A,  $L_{OUT} = 2 \times 2.2 \ \mu H$  parallel,  $C_{OUT} = 88 \ \mu F$ . The efficiency is shown for several output voltage levels ( $V_{LED}$ ) versus output current.

Figure 7-11 depict the efficiency versus input voltage ( $V_{ILLUM\_A\_VIN}$ ) at various output voltage levels ( $V_{LED}$ ) for an output current of 16 A.



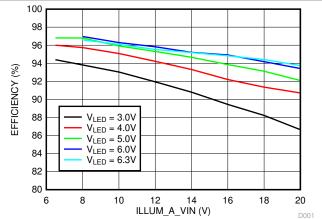


Figure 7-11. Illumination Driver Plus Power FETs Efficiency vs V<sub>ILLUM\_A\_IN</sub> (I<sub>OUT</sub> = 16 A)

#### 7.3.3 External Power FET Selection

The DLPA3005 requires five external N-type Power FETs for proper operation. Two power FETs are required for the illumination buck converter section (FETs  $L_{\text{EXT}}$  and  $M_{\text{EXT}}$  in Figure 8-3) and three power FETs are required for the LED selection switches (FETs  $P_{\text{EXT}}$ ,  $Q_{\text{EXT}}$ , and  $R_{\text{EXT}}$  in Figure 8-3). This section discusses the selection criteria for these FETs:

- Threshold voltage
- · Gate charge and gate timing
- R<sub>DS(ON)</sub>

### 7.3.3.1 Threshold Voltage

The DLPA3005 has five drive outputs for the respective five power FETs. The signal swing at these outputs is about 5 V. Thus, FETs should be selected that are turned on adequately with a gate-source voltage of 5 V. For the three LED selection outputs (CHx\_GATE\_CTRL) and the low-side drive (ILLUM\_LSIDE\_DRIVE), the drive signal is ground referred. For the ILLUM\_HSIDE\_DRIVE output the signal swing is referred to the switch node of the converter, ILLUM\_A\_SW. All five power FETs should be N-type.

### 7.3.3.2 Gate Charge and Gate Timing

For power FETs a typically specified parameter is the total gate charge required to turn-on or turn-off the FET. The selection of the illumination buck-converter FETs with respect to their total gate charge is mainly relative to gate-source rise and fall times. For proper operation it is advised to have the gate-source rise and fall times maximum on the order of 20 ns–30 ns. Given the typical high-side driver pullup resistance of about 5 Ohm, an equivalent maximum gate capacitance of 4-6nF is appropriate. Since the gate-source swing is about 5 V, a total turn-on/off gate charge of maximum 20 nC–30 nC is therefore advised.

The DPLA3005 has built-in non-overlap timing to prevent that both the high-side and low-side FET of the illumination buck converter are turned-on simultaneously. The typical non-overlap timing is about 35 ns. In most applications this should give sufficient margins. On top of this non-overlap timing the DLPA3005 measures the gate-source voltage of the external FETs to determine whether a FET is actually on or off. This measurement is done at the pins of the DLPA3005. For the low-side FET this measurement is done between ILLUM\_LSIDE\_DRIVE and ILLUM\_A\_GND. Similarly, for the high-side FET the gate-source voltage is measured between ILLUM\_HSIDE\_DRIVE and ILLUM\_A\_SW. The location of these measurement nodes imply that at all times no additional drivers or circuitry should be inserted between the DLPA3005 and the external power FETs of the buck converter. Inserting circuitry (delays) could potentially lead to incorrect on-off detection of the FETs and cause shoot-through currents. These shoot-through currents are negatively affecting the efficiency, but more seriously can potentially damage the power FETs.

For the LED selection switches no specific selection criteria are present on gate charge / timing. This is because the timing of the LED selection signals is in the microsecond range rather than nanosecond range.

## 7.3.3.3 R<sub>DS(ON)</sub>

The selection of the FET relative to its drain-source on-resistance,  $R_{DS(ON)}$ , has two aspects. First, for the high-side FET of the illumination buck-converter, the  $R_{DS(ON)}$  is a factor in the overcurrent detection. Second, for the other four FETs, the power dissipation drives the choice of the FETs  $R_{DS(ON)}$ .

To detect an overcurrent situation, the DLPA3005 measures the drain-source voltage drop of the high-side FET when turned on. The overcurrent detection circuit triggers, and switches off the high-side FET, when the threshold  $V_{DC-Th}$  = 185 mV (typical) is reached. Therefore, the actual current,  $I_{OC}$ , at which this overcurrent detection triggers, is given by:

$$I_{OC} = \frac{V_{DC-Th}}{R_{DS(ON)}} = \frac{185 \text{ mV}}{R_{DS(ON)}}$$
 (6)

Note that the  $R_{DS(ON)}$  should be taken from the FET data sheet at high-temperature, that is, at overcurrent the FETs will likely by hot.

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For example, the CSD17510Q5A NexFET has an  $R_{DS(ON)}$  of 7 m $\Omega$  at 125°C. Using this FET will result in an overcurrent level of 26 A. This FET would be a good choice for a 16 A application.

For the low-side FET and the three LED selection FETs the  $R_{DS(ON)}$  selection is mainly governed by the power dissipation due to conduction losses. The power dissipated in these FETs is given by:

$$P_{DISS} = \int_{t} I_{DS}^{2}(t) R_{DS(ON)}$$
(7)

In which  $I_{DS}$  is the current running through the respective FET. The lower the  $R_{DS(ON)}$ , the lower is the dissipation.

For example, the CSD17501Q5A has  $R_{DS(ON)}$ = 3 m $\Omega$ . For a drain-source current of 16 A with a duty cycle of 25% (assuming the FET is used as LED selection switch), the dissipation is about 0.2 W in this FET.

## 7.3.4 DMD Supplies

This block contains all the supplies needed for the DMD and DLPC (Figure 7-12). The block comprises:

- LDO\_DMD: for internal supply
- DMD\_HV: regulator generates high voltage supplies
- Two buck converters: for DLPC/DMD voltages

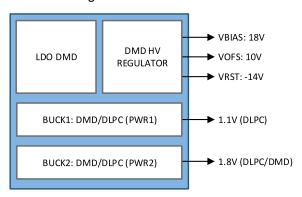


Figure 7-12. DMD Supplies Blocks

The DMD supplies block is designed to work with the DMD and the related DLPC. The DMD has its own set of supply voltage requirements. Besides the three high voltages, two supplies are needed for the DMD and the related DLPC (DLPC343x-family for instance). These supplies are made by two buck converters.

The EEPROM of the DLPA3005 is factory programmed for a certain configuration, such as which buck converters are used. Which configuration is programmed in EEPROM can be read in the capability register. It concerns the following bits:

- DMD BUCK1 USE
- DMD\_BUCK2\_USE

### 7.3.4.1 LDO DMD

This regulator is dedicated to the DMD supplies block and provides an analog supply voltage of 5.5 V to the internal circuitry.

## 7.3.4.2 DMD HV Regulator

The DMD HV regulator generates three high voltage supplies: DMD\_VRESET, DMD\_VBIAS, and DMD\_VOFFSET (Figure 7-13). The DMD HV regulator uses a switching regulator (switch A-D), where the inductor is time shared between all three supplies. The inductor is charged up to a certain current value (current limit) and then discharged into one of the three supplies. If not all supplies need charging the time available will be equally shared between those that do need charging.

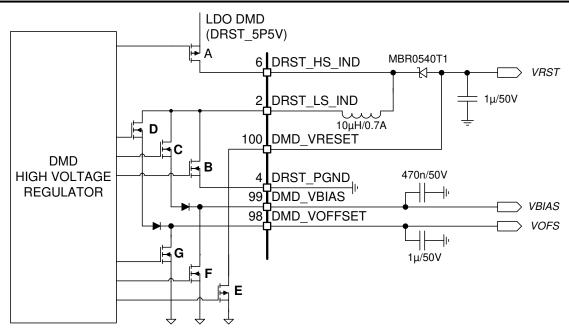


Figure 7-13. DMD High Voltage Regulator

### 7.3.4.3 DMD/DLPC Buck Converters

Each of the two DMD buck converters creates a supply voltage for the DMD and/or DLPC. The values of the voltages for the DMD and DLPC used, for instance:

DMD+DLPC3439: 1.1 V (DLPC) and 1.8 V (DLPC/DMD)

The topology of the buck converters is the same as the general purpose buck converter discussed later in this document. How to configure the inductor and capacitor will be discussed in Section 7.3.5.

A typical configuration is 3.3  $\mu$ H for the inductor and 2 × 22  $\mu$ F for the output capacitor.



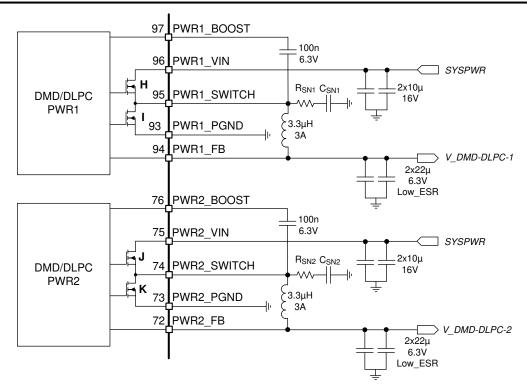


Figure 7-14. DMD/DLPC Buck Converters



### 7.3.4.4 DMD Monitoring

The DMD block is continuously monitored for failures to prevent damage to the DLPA3005 and/ or the DMD. Several possible failures are monitored such that the DMD voltages can be ensured. Failures could be for instance a broken control loop or a too high or too low converter output voltage. The overall DMD fault bit is in Main Status register, DMD\_FAULT. If any of the failures in Table 7-2 occur, the DMD\_FAULT bit will be set high.

**POWER GOOD BLOCK** REGISTER BIT **THRESHOLD** DMD VRESET: 90%. **HV** Regulator DMD\_PG\_FAULT DMD VOFFSET and DMD VBIAS: 86% rising, 66% falling PWR1 BUCK DMD1 PG FAULT Ratio: 72% PWR2 BUCK\_DMD2\_PG\_FAULT Ratio: 72% LDO GP2 PG FAULT / PWR3 (LDO 2) 80% rising, 60% falling LDO DMD1 PG FAULT LDO GP1 PG FAULT / PWR4 (LDO\_1) 80% rising, 60% falling LDO DMD1 PG FAULT **OVER-VOLTAGE BLOCK** REGISTER BIT THRESHOLD (V) PWR1 BUCK DMD1 OV FAULT Ratio: 120% PWR2 BUCK DMD2 OV FAULT Ratio: 120% LDO GP2 OV FAULT / PWR3 (LDO\_2) LDO\_DMD1\_OV\_FAULT LDO\_GP1 OV FAULT / PWR4 (LDO\_1) LDO DMD1 OV FAULT

Table 7-2. DMD FAULT Indication

#### 7.3.4.4.1 Power Good

The DMD HV regulator, DMD buck converters, DMD LDOs, and the LDO\_DMD that supports the HV regulator have a power good indication.

The DMD HV regulator is continuously monitored to check if the output rails DMD\_VRESET, DMD\_VOFFSET, and DMD\_VBIAS are in regulation. If either one of the output rails drops out of regulation (for example, due to a shorted output or overloading), the DMD\_ PG\_FAULT bit in Detailed Status Register3 is set. Threshold for DMD\_VRESET is 90% and the thresholds for DMD\_VOFFSET/ DMD\_VBIAS are 86% (rising edge) and 66% (falling edge).

The power good signal for the two DMD buck converters indicate if their output voltage (PWR1\_FB and PWR2\_FB) are within a defined window. The relative power good ratio is 72%. This means that if the output voltage is below 72% of the set output voltage the power good bit is asserted. The power good bits are in register BUCK DMD1 PG FAULT and BUCK DMD2 PG FAULT.

DMD\_LDO1 and DMD\_LDO2 output voltages are also monitored. When the power good fault of the LDO is asserted it implies that the LDO voltage is below 80% (rising edge) or 60% (falling edge) of its intended value. The power good indication for the LDOs is in register LDO\_GP1\_PG\_FAULT / LDO\_DMD1\_PG\_FAULT and LDO GP2 PG FAULT / LDO DMD2 PG FAULT.

The LDO\_DMD used for the DMD HV regulator has its own power good signaling. The power good fault of the LDO\_DMD is asserted if the LDO voltage is below 80% (rising edge) or 60% (falling edge) of its intended value. The power good indication for this LDO is in register V5V5\_LDO\_DMD\_PG\_FAULT.

#### 7.3.4.4.2 Overvoltage Fault

An overvoltage fault occurs when an output voltage rises above a pre-defined threshold. Overvoltage faults are indicated for the DMD buck converters, DMD LDOs and the LDO\_DMD supporting the DMD HV regulator. The overvoltage fault of LDO1 and LDO2 are not incorporated in the overall DMD FAULT when the LDOs are used

as general purpose LDOs. Table 7-2 provides an overview of the possible DMD overvoltage faults and their threshold levels.

#### 7.3.5 Buck Converters

The DLPA3005 contains one general purpose buck converter and a supporting LDO (LDO\_BUCKS). The programmable 8-bit buck converter can generate a voltage between 1 V and 5 V and have an output current limit of 3 A. General purpose buck2 (PWR6) is currently supported. One buck converter and the LDO\_BUCKS is depicted in Figure 7-15.

The two DMD/DLPC buck converters discussed earlier in Section 7.3.4 have the same architecture as these three buck converters and can be configured in the same way.

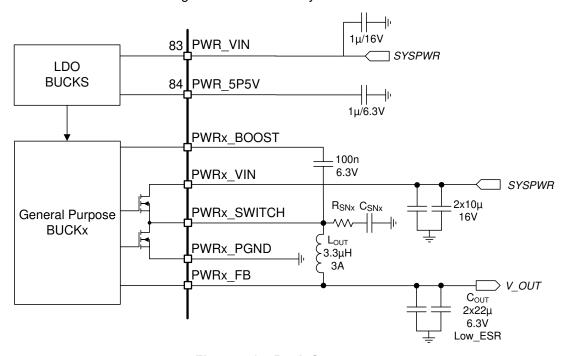


Figure 7-15. Buck Converter

### 7.3.5.1 LDO Bucks

This regulator supports the general purpose buck converter and the two DMD/DLPC buck converters, and provides an analog voltage of 5.5 V to the internal circuitry.

### 7.3.5.2 General Purpose Buck Converter

The Buck converter is for general purpose usage (Figure 7-15). The converter can be enabled or disabled through the Enable Register, 0x01 bit:

### · BUCK GP2 EN

The output voltage of the converter is configurable between 1 V and 5 V with an 8-bit resolution. This can be done through the register BUCK\_GP2\_TRIM.

General purpose buck2 (PWR6) has a current capability of 2 A.

The buck converter can operate in two switching modes: Normal, 600-kHz switching frequency mode and the skip mode. The skip mode is designed to increase light load efficiency. As the output current decreases from heavy load condition, the inductor current is also reduced and eventually comes to point that its rippled valley touches zero level, which is the boundary between continuous conduction and discontinuous conduction modes. The rectifying MOSFET is turned off when its zero inductor current is detected. As the load current further decreases the converter run into discontinuous conduction mode. The on-time is kept almost the same as it was in the continuous conduction mode so that it takes longer time to discharge the output capacitor with smaller

load current to the level of the reference voltage. The skip mode can be enabled/disabled the buck converter in register BUCK SKIP ON.

### 7.3.5.3 Buck Converter Monitoring

The buck converter block is continuously monitored for system failures to prevent damage to the DLPA3005 and peripherals. Several possible failures are monitored such as a too high or too low output voltage. The possible faults are summarized in Table 7-3.

Table 7-3. Buck Converter Fault Indication

POWER GOOD				
BLOCK	REGISTER BIT	THRESHOLD (RISING EDGE)		
Gen.Buck2	BUCK_GP2_PG_FAULT	Ratio 72%		
OVERVOLTAGE				
Gen.Buck2	BUCK_GP2_OV_FAULT	Ratio 120%		

#### 7.3.5.3.1 Power Good

The buck converter as well as the supporting LDO BUCK have a power good indication. The buck converter has a separate indication.

The power good for the buck converter indicate if their output voltage (PWR6 FB) is within a defined window. The relative power good ratio is 72%. This means that if the output voltage is below 72% of the set voltage the PG fault bit is set high. The power good bit of the buck converter is in the Detailed status register1 bit:

BUCK GP2 PG FAULT for BUCK2 (PWR6)

The LDO BUCKS that supports the buck converters has its own power good indication. The power good of the LDO BUCKS is asserted if the LDO voltage is below 80% (rising edge) or 60% (falling edge) of its intended value. The power good indication for the LDO BUCKS is in Detailed status register3, V5V5 LDO BUCK PG FAULT.

#### 7.3.5.3.2 Overvoltage Fault

An overvoltage fault occurs when an output voltage rises above a predefined threshold. Overvoltage faults are indicated for the buck converter and LDO BUCKS. The overvoltage fault of the LDO BUCKS is asserted if the LDO voltage is above 7.2 V and can be found in register V5V5 LDO BUCK OV FAULT. The overvoltage of the general purpose buck converter is 120% of the set value and can be read through the register BUCK\_GP1,2,3\_OV\_FAULT.

### 7.3.5.4 Buck Converter Efficiency

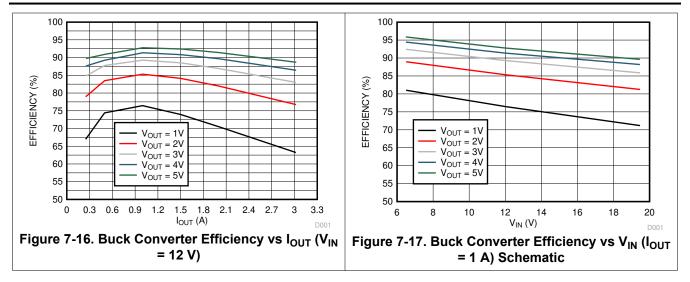
Figure 7-16 shows an overview of the efficiency of the buck converter for an input voltage of 12 V. The efficiency is shown for several output voltage levels where the load current is swept.

Figure 7-17 depicts the buck converter efficiency versus input voltage (V<sub>IN</sub>) for a load current (I<sub>OUT</sub>) of 1 A for various output voltage levels (V<sub>OUT</sub>).

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### 7.3.6 Auxiliary LDOs

LDO\_1 and LDO\_2 are the two auxiliary LDOs that can freely be used by an additional external application. All other LDOs are for internal usage only and should not be loaded. LDO1 (PWR4) is a fixed voltage of 3.3 V, while LDO2 (PWR3) is a fixed voltage of 2.5 V. Both LDOs are capable to deliver 200 mA.

### 7.3.7 Measurement System

The measurement system (Figure 7-18) is designed to sense internal and external nodes and convert them to digital by the implemented AFE comparator. The AFE can be enabled through register AFE\_EN. The reference signal for this comparator, ACMPR\_REF, is a low pass filtered PWM signal coming from the DLPC. To be able to cover a wide range of input signals a variable gain amplifier (VGA) is added with three gain settings (1x, 9.5x, and 18x). The gain of the VGA can be set through register AFE\_GAIN. The maximum input voltage of the VGA is 1.5 V. Some of the internal voltage are too large though to be handled by the VGA and are divided down first.

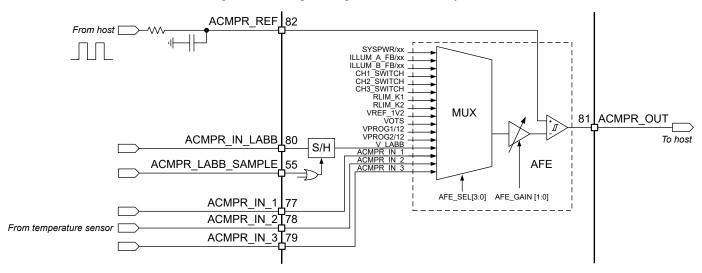


Figure 7-18. Measurement System Schematic

The multiplexer (MUX) connects to a wide range of nodes. Selection of the MUX input can be done through register AFE SEL. Signals that can be selected:

- System input voltage, SYSPWR
- LED anode cathode voltage, ILLUM A FB
- LED cathode voltage, CHx\_SWITCH
- V\_R<sub>LIM</sub> to measure LED current

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- Internal reference, VREF\_1V2
- Die Temperature represented by voltage VOTS
- EEPROM programming voltage, VPROG1,2/12
- · LABB sensor, V LABB
- External sense pins, ACMPR\_IN\_1,2,3

The system input voltage SYSPWR can be measured by selecting the SYSPWR/xx input of the MUX. Before the system input voltage is supplied to the MUX the voltage needs to be divided. This is because the variable gain amplifier (VGA) can handle voltages up-to 1.5 V whereas the system voltage can be as high as 20 V. The division is done internally in the DLPA3005. The division factor selection (VIN division factor) is combined with the auto LED turn off functionality of the illumination driver and can be set through register ILLUM\_LED\_AUTO\_OFF\_SEL.

The LED voltages can be monitored by measuring both the common anode of the LEDs as well as the cathode of each LED individually. The LED anode voltage (V<sub>LED</sub>) is measured by sensing the feedback pin of the illumination driver (ILLUM\_A\_FB). Likewise the SYSPWR, the LED anode voltage needs to be divided before feeding it to the MUX. The division factor is combined with the overvoltage fault level of the illumination driver and can be set through register VLED\_OVP\_VLED\_RATIO. The cathode voltages CH1,2,3\_SWITCH are fed directly to the MUX without division factor.

The LED current can be determined knowing the value of sense resistor R<sub>LIM</sub> and the voltage across the resistor. The voltage at the top-side of the sense resistor can be measured by selecting MUX-input RLIM\_K1. The bottom side of the resistor is connected to GND.

VOTS is connected to an on-chip temperature sensor. The voltage is a measure for the chip's junction temperature: Temperature ( $^{\circ}$ C) = 300 × VOTS (V) – 270

For storage of trim bits, but also for the USER EEPROM bytes, the DLPA3005 has two EEPROM blocks. The programming voltage of EEPROM block 1 and 2 can be measured through MUX input VPROG1/12 and VPROGR2/12, respectively. The EEPROM programming voltage is divided by 12 before it is supplied to the MUX to prevent a too large voltage on the MUX input. The EEPROM programming voltage is about 12 V.

LABB is a feature that is Local Area Brightness Boost. LABB increases the brightness locally while maintaining good contrast and saturation. The sensor needed for this feature should be connected to pin ACMPR\_IN\_LABB. The light sensor signal is sampled and held such that it can be read independently of the sensor timing. To use this feature it should be ensured that:

- The AFE block is enabled (AFE EN = 1).
- The LABB input is selected (AFE SEL<3:0>=3h).
- The AFE gain is set appropriately to have AFE Gain × VLABB < 1.5 V (AFE GAIN<1:0>).

Sampling of the signal can be done through one of the following methods:

- 1. Writing to register TSAMPLE\_SEL by specifying the sample time window and set bit SAMPLE\_LABB=1 to start sampling. The SAMPLE\_LABB bit is automatically reset to 0 at the end of the sample period to be ready for a next sample request.
- 2. Use the input ACMPR\_LABB\_SAMPLE-pin as a sample signal. As long as this signal is high the signal on ACMPR\_IN\_LABB is tracked. Once the ACMP\_LABB\_SAMPLE is set low again the value at that moment will be held.

ACMPR\_IN\_1,2,3 can measure external signals from for instance a temperature sensor. It should be ensured that the voltage on the input does not exceed 1.5 V.

#### 7.4 Device Functional Modes

**Table 7-4. Modes of Operation** 

MODE	DESCRIPTION
OFF	This is the lowest-power mode of operation. All power functions are turned off, registers are reset to their default values, and the IC does not respond to SPI commands. RESET_Z pin is pulled low. The IC will enter OFF mode whenever the PROJ_ON pin is low.



## **Table 7-4. Modes of Operation (continued)**

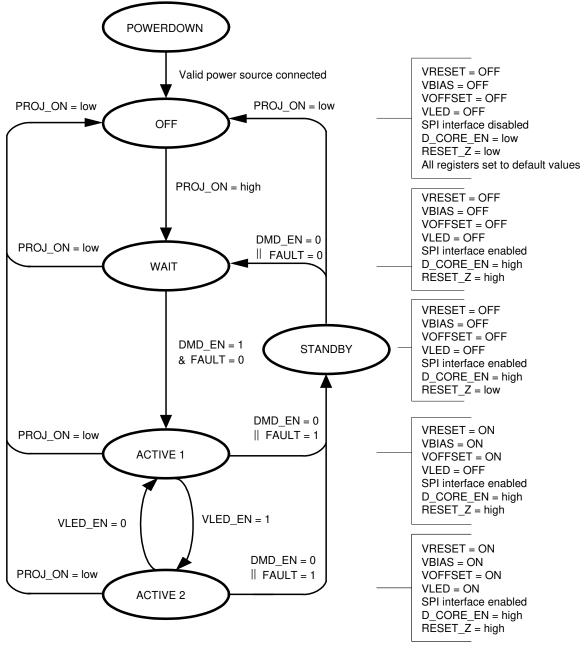
MODE	DESCRIPTION
WAIT	The DMD regulators and LED power (V <sub>LED</sub> ) are turned off, but the IC does respond to the SPI. The device enters WAIT mode whenever PROJ_ON is set high, DMD_EN <sup>(1)</sup> bit is set to 0 or a FAULT is resolved.
STANDBY	The device also enters STANDBY mode when a fault condition is detected <sup>(2)</sup> . (See also Section 7.5.2). Once the fault condition is resolved, WAIT mode is entered.
ACTIVE1	The DMD supplies are enabled but LED power ( $V_{LED}$ ) is disabled. PROJ_ON pin must be high, DMD_EN bit must be set to 1, and ILLUM_EN <sup>(3)</sup> bit is set to 0.
ACTIVE2	DMD supplies and LED power are enabled. PROJ_ON pin must be high and DMD_EN and ILLUM_EN bits must both be set to 1.

- (1) Settings can be done through register 0x01.
   (2) Power-good faults, overvoltage, overtemperature shutdown, and undervoltage lockout
- Settings can be done through register 0x01; the bit is named ILLUM\_EN. (3)

## Table 7-5. Device State as a Function of Control-Pin Status

PROJ_ON Pin	STATE
LOW	OFF
HIGH	WAIT STANDBY ACTIVE1 ACTIVE2 (The device state depends on DMD_EN and ILLUM_EN bits and whether there are any fault conditions.)

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- A. || = OR, & = AND
- B. FAULT = Undervoltage on any supply, thermal shutdown, or UVLO detection
- C. UVLO detection, per the diagram, causes the DLPA3005 to go into the standby state. This is not the lowest power state. If lower power is desired, PROJ\_ON should be set low.
- D. DMD\_EN register bit can be reset or set by SPI writes. DMD\_EN defaults to 0 when PROJ\_ON goes from low to high and then the DLPC ASIC software automatically sets it to 1. Also, FAULT = 1 causes the DMD\_EN register bit to be reset.
- ${\sf E.}\quad {\sf D\_CORE\_EN} \ is \ a \ signal\ internal\ to\ the\ {\sf DLPA3005}.\ This\ signal\ turns\ on\ the\ {\sf VCORE\ regulator}.$

#### Figure 7-19. State Diagram

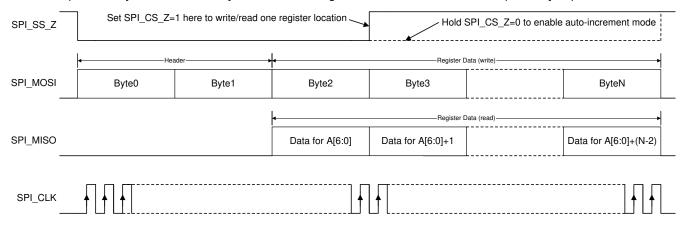
## 7.5 Programming

This section discusses the serial protocol interface (SPI) of the DLPA3005 as well as the interrupt handling, device shutdown and register protection.



#### 7.5.1 SPI

The DLPA3005 provides a 4-wire SPI port that supports two SPI clock frequency modes: 0 MHz to 36 MHz and 20 MHz to 40 MHz. The clock frequency mode can be set in register DIG SPI FAST SEL. The interface supports both read and write operations. The SPI SS Z input serves as the active low chip select for the SPI port. The SPI SS Z input must be forced low for writing to or reading from registers. When SPI SS Z is forced high, the data at the SPI MOSI input is ignored, and the SPI MISO output is forced to a high-impedance state. The SPI MOSI input serves as the serial data input for the port; the SPI MISO output serves as the serial data output. The SPI\_CLK input serves as the serial data clock for both the input and output data. Data at the SPI MOSI input is latched on the rising edge of SPI CLK, while data is clocked out of the SPI MISO output on the falling edge of SPI CLK. Figure 7-20 illustrates the SPI port protocol. Byte 0 is referred to as the command byte, where the most significant bit is the write/not-read bit. For the W/nR bit, a 1 indicates a write operation, while a 0 indicates a read operation. The remaining seven bits of the command byte are the register address targeted by the write or read operation. The SPI port supports write and read operations for multiple sequential register addresses through the implementation of an auto-increment mode. As shown in Figure 7-20, the auto-increment mode is invoked by simply holding the SPI SS Z input low for multiple data bytes. The register address is automatically incremented after each data byte transferred, starting with the address specified by the command byte. After reaching address 0x7Fh the address pointer jumps back to 0x00h.



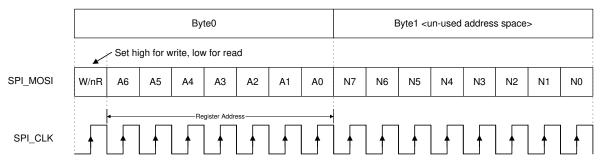


Figure 7-20. SPI Protocol

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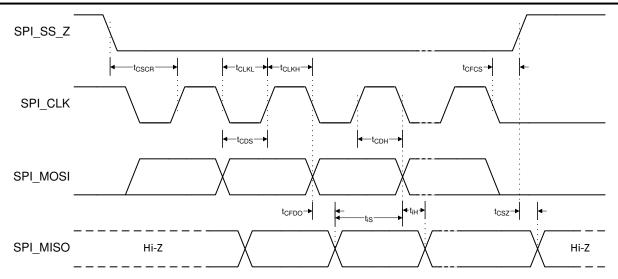


Figure 7-21. SPI Timing Diagram

## 7.5.2 Interrupt

The DLPA3005 has the capability to flag for several faults in the system, such as overheating, power good and over voltage faults. If a certain fault condition occurs one or more bits in the interrupt register will be set. The setting of a bit in the Main Status register triggers an interrupt event, which pulls down the INT\_Z pin. Interrupts can be masked by setting the respective MASK bits in the Interrupt Mask register. Setting a MASK bit prevents the INT\_Z from being pulled low for the particular fault condition. Some high-level faults comprise multiple low-level faults. The high-level faults can be read in Main Status register, while the lower-level faults can be read in Detailed status register1 through Detailed status register 4. Table 7-6 provides an overview of the faults and how they are related.

**Table 7-6. Interrupt Registers** 

HIGH-LEVEL	MID-LEVEL	LOW-LEVEL
		DMD_PG_FAULT
		BUCK_DMD1_PG_FAULT
		BUCK_DMD1_OV_FAULT
		BUCK_DMD2_PG_FAULT
	DMD_FAULT	BUCK_DMD2_OV_FAULT
SUPPLY_FAULT		LDO_GP1_PG_FAULT / LDO_DMD1_PG_FAULT
		LDO_GP1_OV_FAULT / LDO_DMD1_OV_FAULT
		LDO_GP2_PG_FAULT / LDO_DMD2_PG_FAULT
		LDO_GP2_OV_FAULT / LDO_DMD2_OV_FAULT
	BUCK_GP2_PG_FAULT	
	BUCK_GP2_OV_FAULT	
	ILLUM_BC1_PG_FAULT	
  ILLUM_FAULT	ILLUM_BC1_OV_FAULT	
TEEOM_I AOEI	ILLUM_BC2_PG_FAULT	
	ILLUM_BC2_OV_FAULT	
PROJ_ON_INT		
TS_SHUT		
TS_WARN		



#### 7.5.3 Fast-Shutdown in Case of Fault

The DLPA3005 has two shutdown modes: a normal shutdown initiated after pulling PROJ\_ON level low and a fast power-down mode. The fast power down feature can be enabled/disabled through register 0x01, FAST\_SHUTDOWN\_EN. By default, the mode is enabled.

When the fast power-down feature is enabled, a fast shutdown is initiated for specific faults. This shutdown happens autonomously from the DLPC. The DLPA3005 enters the fast-shutdown mode only for specific faults; thus, not for all the faults flagged by the DLPA3005. The faults for which the DLPA3005 goes into fast-shutdown are listed in Table 7-7.

Table 7-7. Faults that Trigger a Fast-Shutdown

HIGH-LEVEL	LOW-LEVEL
BAT_LOW_SHUT	·
TS_SHUT	
	DMD_PG_FAULT
	BUCK_DMD1_PG_FAULT
	BUCK_DMD1_OV_FAULT
	BUCK_DMD2_PG_FAULT
DMD_FAULT	BUCK_DMD2_OV_FAULT
	LDO_GP1_PG_FAULT / LDO_DMD1_PG_FAULT
	LDO_GP1_OV_FAULT / LDO_DMD1_OV_FAULT
	LDO_GP2_PG_FAULT / LDO_DMD2_PG_FAULT
	LDO_GP2_OV_FAULT / LDO_DMD2_OV_FAULT
ILLUM_FAULT	ILLUM_BC1_OV_FAULT
	ILLUM_BC2_OV_FAULT

#### 7.5.4 Protected Registers

By default all regular USER registers are writable, except for the READ ONLY registers. Registers can be protected though to prevent accidental write operations. By enabling the protecting, only USER registers are writable. Protection can be enabled/ disabled through register PROTECT USER REG.

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# 7.6 Register Maps

Register Address, Default, R/W, Register name. **Boldface** settings are the hardwired defaults.

Table 7-8. Register Map

Table 7-8. Register Map  NAME BITS DESCRIPTION									
	DI13		DE	SORIF HUN					
0x00, E3, R/W, Chip Identification	[7:41	Chin identification	short F (horr)						
CHIPID	[7:4]	· ·	Chip identification number: E (hex)						
REVID	[3:0]	Revision number, 3 (he	ex)						
0x01, 82, R/W, Enable Register									
FAST_SHUTDOWN_EN	[7]	-	): Fast shutdown disabled I: Fast shutdown enabled						
CW_EN	[6]	Reserved							
BUCK_GP2_EN	[4]	0: General purpose but 1: General purpose but							
ILLUM_LED_AUTO_OFF_EN	[2]	0: Illum_led_auto_off 1: Illum_led_auto_off_e							
ILLUM_EN	[1]	0: Illum regulators disa  1: Illum regulators er							
DMD_EN	[0]	0: DMD regulators dis 1: DMD regulators ena							
0x02, 70, R/W, IREG Switch Contro	I								
	[7]	Reserved, values don'	t care						
		Rlim voltage top-side (mV). Illum current limit = Rlim voltage / Rlim							
		0000: 17	1000: 73						
		0001: 20	1001: 88						
		0010: 23	1010: 102						
ILLUM_ILIM	[6:3]	0011: 25	1011: 117						
		0100: 29	1100: 133						
		0101: 37	1101: 154						
		0110: 44	1110: 176						
		0111: 59	1111: 197						
ILLUM_SW_ILIM_EN	[2:0]	Bit1: CH2, MOSFET C	transient current lim	iit (0:disabled, 1:enabled) iit (0:disabled, 1:enabled) iit (0:disabled, 1:enabled)					
0x03, 00, R/W, SW1_IDAC(1)									
	[7:2]	Reserved, values don'	t care						
SW1_IDAC<9:8>	[1:0]	Led current of CH1(A) = ((Bit value + 1)/1024) $\times$ (150 mV / Rlim), Most significant bits of 10 bits register (register 0x03 and 0x04). <b>00 0000 0000 [OFF]</b> 00 0011 0011 [(52/1024) $\times$ (150mV/Rlim)], Minimum code							
		11 1111 1111 [150mV/F	Rlim]						



## **Table 7-8. Register Map (continued)**

NAME	BITS	DESCRIPTION
0x04, 00, R/W, SW1_IDAC(2)		
SW1_IDAC<7:0>	[7:0]	Led current of CH1(A) = ((Bit value + 1)/1024) × (150 mV / Rlim), Least significant bits of 10 bits register (register 0x03 and 0x04).  00 0000 0000 [OFF]  00 0011 0011 [(52/1024) × (150mV/Rlim)], Minimum code 11 1111 1111 [150mV/Rlim]
0x05, 00, R/W, SW2 IDAC(1)		11 TTT [130HV/Xiiii]
0.000, 000, 1000, 0002_15A0(1)	[7:2]	Reserved, value don't care.
SW2_IDAC<9:8>	[1:0]	Led current of CH2(A) = ((Bit value + 1)/1024) × (150 mV / Rlim), Most significant bits of 10 bits register (register 0x05 and 0x06).  00 0000 0000 [OFF]  00 0011 0011 [(52/1024) × (150mV/Rlim)], Minimum code
		11 1111 1111 [150mV/Rlim]
0x06, 00, R/W, SW2_IDAC(2)		
SW2_IDAC<7:0>		Led current of CH2(A) = ((Bit value + 1)/1024) × (150 mV / Rlim), Least significant bits of 10 bits register (register 0x05 and 0x06).  00 0000 0000 [OFF]  00 0011 0011 [(52/1024) × (150mV/Rlim)], Minimum code 11 1111 1111 [150mV/Rlim]
0x07, 00, R/W, SW3_IDAC(1)		
	[7:2]	Reserved, value don't care.
SW3_IDAC<9:8>	[1:0]	Led current of CH3(A) = ((Bit value + 1)/1024) × (150 mV / Rlim), Most significant bits of 10 bits register (register 0x07 and 0x08).  00 0000 0000 [OFF]  00 0011 0011 [(52/1024) × (150mV/Rlim)], Minimum code 11 1111 1111 [150mV/Rlim]
0x08, 00, R/W, SW3 IDAC(2)		THE THE [ISOMEWASHIN]
0.00, 00, 1011, 0113_IDA0(2)		Led current of CH3(A) = ((Bit value + 1)/1024) × (150 mV / Rlim), Least significant bits of 10
SW3_IDAC<7:0>	[7:0]	bits register (register 0x07 and 0x08).  00 0000 0000 [OFF]  00 0011 0011 [(52/1024) × (150mV/Rlim)], Minimum code.
		11 1111 1111 [150mV/Rlim]

## 8 Application and Implementation

#### Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

## 8.1 Application Information

In display applications, using the DLPA3005 provides all needed analog functions including all analog power supplies and the RGB LED driver (up to 16 A per LED and up to 32 A for series LEDs) to provide a robust and efficient display solution. Each DLP application is derived primarily from the optical architecture of the system and the format of the data coming into the DLPC3439 DLP controller chips.

#### 8.2 Typical Application

A common application when using DLPA3005 is to use it with a 0.47 1080 DMD (DLP4710) and two DLPC3439 controllers for creating a small, ultra-portable projector. The DLPC3439s in the projector typically receive images from a PC or video player using HDMI or VGA analog as shown in Figure 8-1. Card readers and Wi-Fi can also be used to receive images if the appropriate peripheral chips are added. The DLPA3005 provides power supply sequencing and control of the RGB LED currents as required by the application.

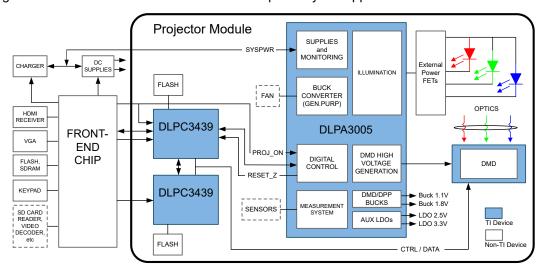


Figure 8-1. Typical Setup Using DLPA3005

#### 8.2.1 Design Requirements

An ultra-portable projector can be created by using a DLP chip set comprised of a 0.47 1080 DMD (DLP4710), two DLPC3439s controllers, and the DLPA3005 PMIC/LED Driver. The two DLPC3439s do the digital image processing, the DLPA3005 provides the needed analog functions for the projector, and DMD is the display device for producing the projected image. In addition to the three DLP chips in the chip set, other chips may be needed. At a minimum a Flash part is needed to store the software and firmware to control the two DLPC3439s. The illumination light that is applied to the DMD is typically from red, green, and blue LEDs. These are often contained in three separate packages, but sometimes more than one color of LED die may be in the same package to reduce the overall size of the projector. Power FETs are needed external to the DLPA3005 so that high LED currents can be supported. For connecting the two DLPC3439s to the front end chip for receiving images the parallel interface is typically used. While using the parallel interface, I<sup>2</sup>C should be connected to the front end chip for inputting commands to the two DLPC3439s.

The DLPA3005 has three built-in buck switching regulators to serve as projector system power supplies. Two of the regulators are fixed to 1.1 V and 1.8 V for powering the DLP chip set. The remaining one buck regulator is available for general purpose use and its voltage is programmable. The regulator can be used to drive variable-speed fan or to power other projector chips such as the front-end chip. The only power supply needed at the DLPA3005 input is SYSPWR from an external DC power supply. The entire projector can be turned on and off by using a single signal called PROJ\_ON. When PROJ\_ON is high, the projector turns on and begins displaying images. When PROJ\_ON is set low, the projector turns off and draws just microamps of current on SYSPWR.

#### 8.2.2 Detailed Design Procedure

3.3 - 5

To connect the 0.47 1080 DMD (DLP4710), two DLPC3439s, and DLPA3005, see the reference design schematic. When a circuit board layout is created from this schematic a very small circuit board is possible. An example small board layout is included in the reference design data base. Layout guidelines should be followed to achieve reliable projector operation. The optical engine that has the LED packages and the DMD mounted to it is typically supplied by an optical OEM who specializes in designing optics for DLP projectors.

The component selection of the buck converter is mainly determined by the output voltage. Table 8-1 shows the recommended value for inductor  $L_{OUT}$  and capacitor  $C_{OUT}$  for a given output voltage.

			001	001	
V <sub>OUT</sub> (V)		L <sub>OUT</sub> (µH)	C <sub>OUT</sub>	· (µF)	
	MIN	TYP	MAX	MIN	MAX
1 – 1.5	1.5	2.2	4.7	22	68
1.5 – 3.3	2.2	3.3	4.7	22	68

22

68

3.3

Table 8-1. Recommended Buck Converter LOUT and COUT

The inductor peak-to-peak ripple current, peak current and RMS current can be calculated using Equation 8, Equation 9 and Equation 10 respectively. The inductor saturation current rating must be greater than the calculated peak current. Likewise, the RMS or heating current rating of the inductor must be greater than the calculated RMS current. The switching frequency of the buck converter is approximately 600 kHz ( $f_{SWITCH}$ ).

$$I_{L\_OUT\_RIPPLE\_P-P} = \frac{\frac{V_{OUT}}{V_{IN\_MAX}} \cdot (V_{IN\_MAX} - V_{OUT})}{L_{OUT} \cdot f_{SWITCH}}$$
(8)

$$I_{L\_OUT\_PEAK} = I_{L\_OUT} + \frac{I_{L\_OUT\_RIPPLE\_P-P}}{2}$$
(9)

$$I_{L\_OUT(RMS)} = \sqrt{I_{L\_OUT}^2 + \frac{1}{12} \cdot I_{L\_OUT\_RIPPLE\_P-P}^2}$$
(10)

The capacitor value and ESR determines the level of output voltage ripple. The buck converter is intended for use with ceramic or other low ESR capacitors. Recommended values range from 22 to 68 µF. Equation 11 can be used to determine the required RMS current rating for the output capacitor.

$$I_{C\_OUT(RMS)} = \frac{V_{OUT} \cdot (V_{IN} - V_{OUT})}{\sqrt{12} \cdot V_{IN} \cdot L_{OUT} \cdot f_{SWITCH}}$$
(11)

Two other components need to be selected in the buck converter configuration. The value of the input-capacitor (pin PWRx\_VIN) should be equal or greater than halve the selected output capacitance  $C_{OUT}$ . In this case  $C_{IN}$  2 × 10  $\mu$ F is sufficient. The capacitor between PWRx\_SWITCH and PWRx\_BOOST is a charge pump capacitor to drive the high side FET. The recommended value is 100 nF.

Since the switching edges of the buck converter are relatively fast, voltage overshoot and ringing can become a problem. To overcome this problem a snubber network is used. The snubber circuit consists of a resistor and capacitor that are connected in series from the switch node to ground. The snubber circuit is used to damp the parasitic inductances and capacitances during the switching transitions. This circuit reduces the ringing voltage and also reduces the number of ringing cycles. The snubber network is formed by RSNx and CSNx. More information on controlling switch-node ringing in synchronous buck converters and configuring the snubber can be found in *Analog Applications Journal*.

#### 8.2.2.1 Component Selection for General-Purpose Buck Converters

The theory of operation of a buck converter is explained in *Understanding Buck Power Stages in Switchmode Power Supplies Application Note*. This section is limited to the component selection. For proper operation, selection of the external components is very important, especially the inductor L<sub>OUT</sub> and the output capacitor C<sub>OUT</sub>. For best efficiency and ripple performance, an inductor and capacitor should be chosen with low equivalent series resistance (ESR).

#### 8.2.3 Application Curve

As the LED currents that are driven time-sequentially through the red, green, and blue LEDs are increased, the brightness of the projector increases. This increase is somewhat non-linear, and the curve for typical white screen lumens changes with LED currents as shown in Figure 8-2. For the LED currents shown, it's assumed that the same current amplitude is applied to the red, green, and blue LEDs. The thermal solution used to heatsink the red, green, and blue LEDs can significantly alter the curve shape shown.

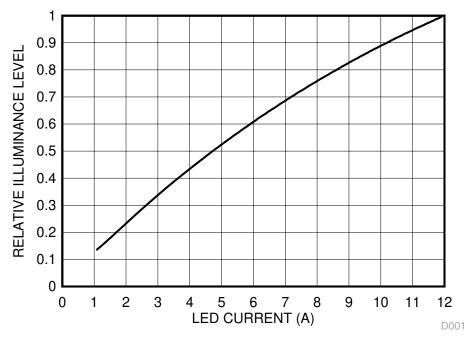


Figure 8-2. Luminance vs LED Current



## 8.3 System Example With DLPA3005 Internal Block Diagram

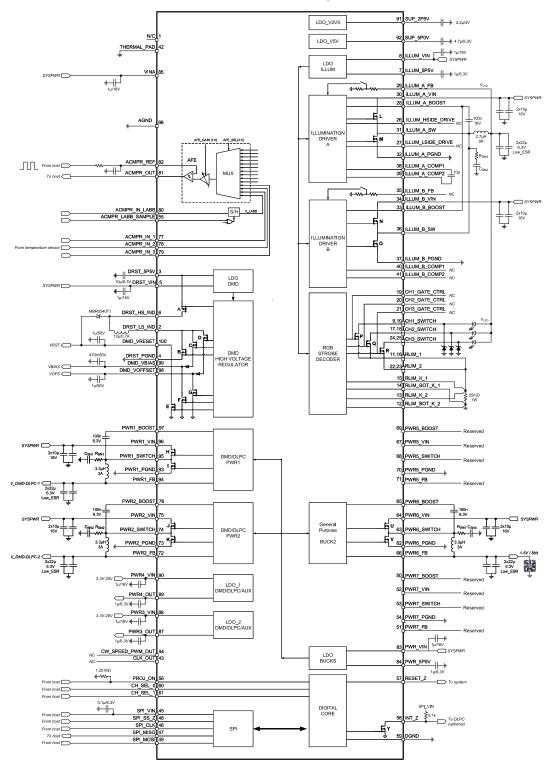


Figure 8-3. Typical Application:  $V_{IN}$  = 12 V,  $I_{OUT}$  = 16 A, LED



## 9 Power Supply Recommendations

The DLPA3005 is designed to operate from a 6 V to 20 V input voltage supply. To avoid insufficient supply current due to line drop, ringing due to trace inductance at the VIN terminals, or supply peak current limitations, additional bulk capacitance may be required. In the case ringing that is caused by the interaction with the ceramic input capacitors, an electrolytic or tantalum type capacitor may be needed for damping.

The amount of bulk capacitance required should be evaluated such that the input voltage can remain in spec long enough for a proper fast shutdown to occur for the VOFFSET, VRESET, and VBIAS supplies. The shutdown begins when the input voltage drops below the programmable UVLO threshold such as when the external power supply is suddenly removed from the system.



#### 9.1 Power-Up and Power-Down Timing

The power-up and power-down sequence is important to ensure a correct operation of the DLPA3005 and to prevent damage to the DMD. The DLPA3005 controls the correct sequencing of the DMD\_VRESET, DMD VBIAS, and DMD VOFFSET to ensure a reliable operation of the DMD.

The general startup sequence of the supplies is described earlier in Section 7.3.1. The power-up sequence of the high voltage DMD lines is especially important in order not to damage the DMD. A too large delta voltage between DMD VBIAS and DMD VOFFSET could cause the damage and should therefore be prevented.

After PROJ\_ON is pulled high, the DMD buck converters and LDOs are powered (PWR1-4) the DMD high voltage lines (HV) are sequentially enabled. First, DMD\_VOFFSET is enabled. After a delay VOFS\_STATE\_DURATION, DMD\_VBIAS is enabled. Finally, again after a delay VBIAS\_STATE\_DURATION, DMD\_VRESET is enabled. Now the DLPA3005 is fully powered and ready for starting projection.

For power down there are two sequences, normal power down (Figure 9-1) and a fault fast power down used in case a fault occurs (Figure 9-2).

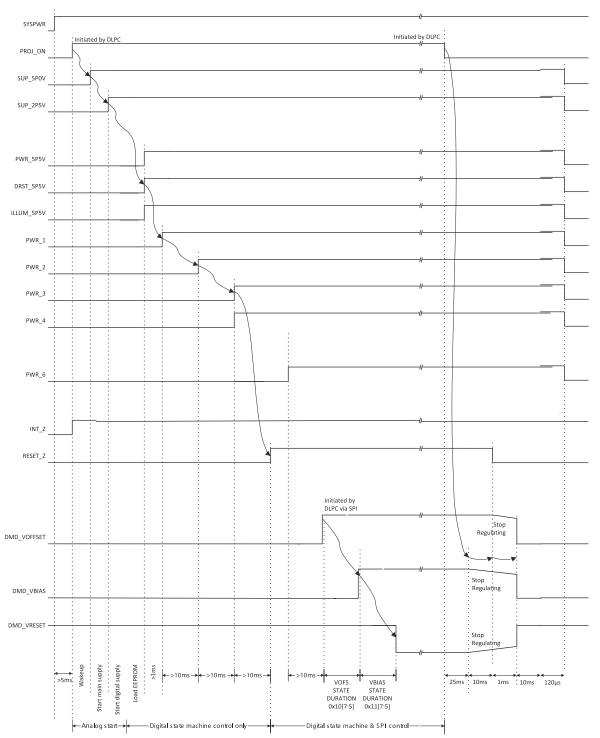
In normal power down mode, the power down is initiated after pulling PROJ\_ON pin low. 25 ms after PROJ\_ON is pulled low, first DMD\_VBIAS and DMD\_VRESET stop regulating, 10 ms later followed by DMD\_VOFFSET. When DMD\_VOFFSET stopped regulating, RESET\_Z is pulled low. 1 ms after the DMD\_VOFFSET stopped regulating, all three voltages are discharged. Finally, all other supplies are turned off. INT\_Z remains high during the power down sequence since no fault occurred. During power down it is ensured that the HV levels do not violate the DMD specifications on these three lines. For this it is important to select the capacitors such that  $C_{VOFFSET}$  is equal to  $C_{VRESET}$  and  $C_{VBIAS}$  is  $\leq C_{VOFFSET}$ ,  $C_{VRESET}$ .

The fast power down mode (Figure 9-2) is started in case a fault occurs (INT\_Z will be pulled low), for instance due to overheating. The fast power down mode can be enabled / disabled through register 0x01, FAST\_SHUTDOWN\_EN. By default the mode is enabled. After the fault occurs, regulation of DMD\_VBIAS and DMD\_VRESET is stopped. The time (delay) between fault and stop of regulation can be controlled through register VBIAS/VRST\_DELAY. The delay can be selected between 4  $\mu$ s and  $\alpha$ 1.1 ms, where the default is  $\alpha$ 540  $\mu$ 5. A defined delay-time after the regulation stopped, all three high voltages lines are discharged and RESET\_Z is pulled low. The delay can be controlled through register VOFS/VRESETZ\_DELAY. Delay can be selected between 4  $\mu$ 5 and  $\alpha$ 1.1 ms. The default is  $\alpha$ 44  $\alpha$ 5. Finally the internal DMD EN signal is pulled low.

The DLPA3005 is now in a standby state. It remains in standby state until the fault resolves. In case the fault resolves, a restart is initiated. It starts then by powering-up PWR\_3 and follows the regular power up, as

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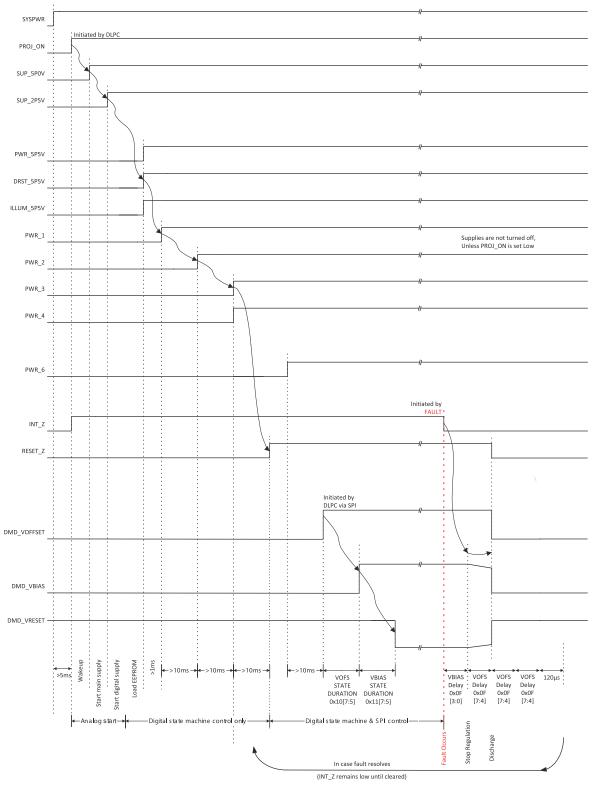
depicted in Figure 9-2. For proper discharge timing and levels, select the capacitors such that  $C_{VOFFSET}$  is equal to  $C_{VRESET}$  and  $C_{VBIAS}$  is  $\leq C_{VOFFSET}$ ,  $C_{VBIAS}$ .



- 1. Arrows indicate sequence of events automatically controlled by digital state machine. Other events are initiated under SPI control.
- 2. SUP\_5P0V and SUP\_2P5V rise to a precharge level with SYSPWR, and reach the full level potential after PROJ\_ON is pulled high.

Figure 9-1. Power Sequence Normal Shutdown Mode





- 1. Arrows indicate sequence of events automatically controlled by digital state machine. Other events are initiated under SPI control.
- 2. SUP\_5P0V and SUP\_2P5V rise to a precharge level with SYSPWR, and reach the full level potential after PROJ\_ON is pulled high.

Figure 9-2. Power Sequence Fault Fast Shutdown Mode

## 10 Layout

## 10.1 Layout Guidelines

For switching power supplies, the layout is an important step in the design, especially when it concerns high peak currents and high switching frequencies. If the layout is not carefully done, the regulator could show stability issues and/or EMI problems. Therefore, it is recommended to use wide and short traces for high current paths and for their return power ground paths. For the DMD HV regulator, the input capacitor, output capacitor, and the inductor should be placed as close as possible to the IC. In order to minimize ground noise coupling between different buck converters it is advised to separate their grounds and connect them together at a central point under the part. For the DMD HV regulator, the recommended value for the capacitors is 1  $\mu$ F for VRST and VOFS, 470 nF for VBIAS. The inductor value is 10  $\mu$ H.

The high currents of the buck converter concentrate around pins VIN, SWITCH and PGND (Figure 10-1). The voltage at the pins VIN, PGND and FB are DC voltages while the pin SWITCH has a switching voltage between VIN and PGND. In case the FET between pins 63 - 64 is closed the red line indicates the current flow while the blue line indicates the current flow when the FET between pins 62 - 63 is closed.

These paths carry the highest currents and must be kept as short as possible.

For the LDO DMD, it is recommended to use a 1  $\mu$ F/16 V capacitor on the input and a 10  $\mu$ F/6.3 V capacitor on the output of the LDO.

For LDO bucks, it is recommended to use a 1  $\mu$ F/16 V capacitor on the input and a 1  $\mu$ F/6.3 V capacitor on the output of the LDO.

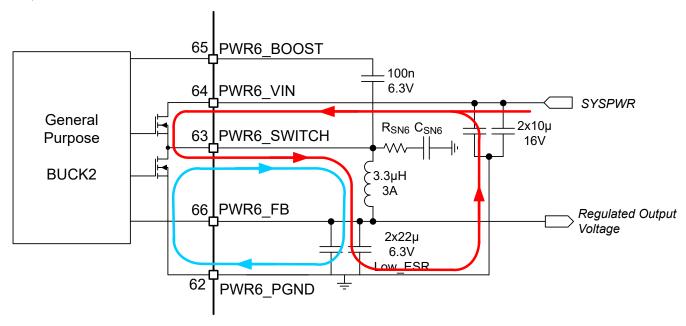


Figure 10-1. High AC Current Paths in a Buck Converter

The trace to the VIN pin carries high AC currents. Therefore, the trace should be low resistive to prevent voltage drop across the trace. Additionally, the decoupling capacitors should be placed as close to the VIN pin as possible.

The SWITCH pin is connected alternately to the VIN or GND. This means a square wave voltage is present on the SWITCH pin with an amplitude of VIN, and containing high frequencies. This can lead to EMI problems if not properly handled. To reduce EMI problems, a snubber network (RSN6 and CSN6) is placed at the SWITCH pin to prevent and/or suppress unwanted high frequency ringing at the moment of switching.

The PGND pin sinks high current and should be connected to a star ground point such that it does not interfere with other ground connections.

The FB pin is the sense connection for the regulated output voltage which is a DC voltage; no current is flowing through this pin. The voltage on the FB pin is compared with the internal reference voltage in order to control the loop. The FB connection should be made at the load such that I•R drop is not affecting the sensed voltage.

#### 10.1.1 SPI Connections

The SPI interface consists of several digital lines and the SPI supply. If routing of the interface lines is not done properly, communication errors can occur. It should be prevented that SPI lines can pickup noise and possible interfering sources should be kept away from the interface.

Pickup of noise can be prevented by ensuring that the SPI ground line is routed together with the digital lines as much as possible to the respective pins. The SPI interface should be connected by a separate own ground connection to the DGND of the DLPA3005 (Figure 10-2). This prevents ground noise between SPI ground references of DLPA3005 and DLPC due to the high current in the system.

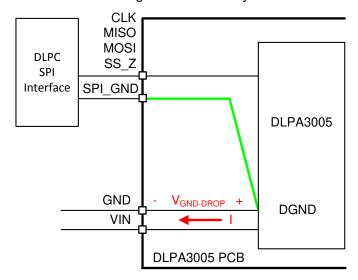


Figure 10-2. SPI Connections

Interfering sources should be kept away from the interface lines as much as possible. If any power lines are routed too close to the SPI\_CLK it could lead to false clock pulses and, thus, communication errors.

#### 10.1.2 R<sub>LIM</sub> Routing

RLIM is used to sense the LED current. To accurately measure the LED current, the RLIM \_K\_1,2 lines should be connected close to the top-side of measurement resistor RLIM, while RLIM\_BOT\_K\_1,2 should be connected close to the bottom-side of RLIM. RLIM \_K\_1,2 and RLIM\_BOT\_K\_1,2 should all have separate traces from their IC pins to their RLIM connection point.

The switched LED current is running through RLIM. Therefore, low-ohmic power and ground connections for RLIM are strongly advised.

#### 10.1.3 LED Connection

High switching currents run through the wiring connecting the external RGB switches and the LEDs. Therefore special attention needs to be paid here. Two perspectives apply to the LED-to-RGB switches wiring:

- 1. The resistance of the wiring, R<sub>series</sub>
- 2. The inductance of the wiring, L<sub>series</sub>

The location of the parasitic series impedances is depicted in Figure 10-3.

(12)

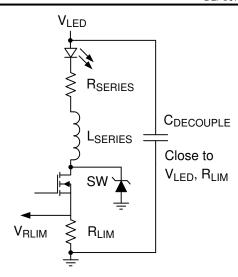


Figure 10-3. Parasitic Inductance (L<sub>Series</sub>) and Resistance (R<sub>series</sub>) in Series with LED

Currents up to 16 A can run through the wires connecting the LEDs to the RGB switches. Some noticeable dissipation can be caused. Every 10 m $\Omega$  of series resistances implies for 16 A average LED current a parasitic power dissipation of 2.5 W. This might cause PCB heating, but more important overall system efficiency is deteriorated.

Additionally the resistance of the wiring might impact the control dynamics of the LED current. It should be noted that the routing resistance is part of the LED current control loop. The LED current is controlled by  $V_{LED}$ . For a small change in  $V_{LED}$  ( $\Delta V_{LED}$ ) the resulting LED current variation ( $\Delta I_{LED}$ ) is given by the total differential resistance in that path, as:

$$\Delta I_{LED} = \frac{\Delta V_{LED}}{r_{LED} + R_{series} + R_{on\_SW\_Q3,Q4,Q5} + R_{LIM}}$$

where

- r<sub>LED</sub> is the differential resistance of the LED.
- R<sub>on SW P,Q,R</sub> the on resistance of the strobe decoder switch.

In this expression  $L_{\text{series}}$  is ignored since realistic values are usually sufficiently low to cause any noticeable impact on the dynamics.

All the comprising differential resistances are in the range of 12.5 m $\Omega$  to several 100's m $\Omega$ . Without paying special attention a series resistance of 100 m $\Omega$  can easily be obtained. It is advised to keep this series resistance sufficiently low, that is, <10 m $\Omega$ .

The series inductance plays an important role when considering the switched nature of the LED current. While cycling through R,G and B LEDs, the current through these branches is turned-on and turned-off in short time duration. Specifically turning off is fast. A current of 16 A goes to 0 A in a matter of 50 ns. This implies a voltage spike of about 1 V for every 5 nH of parasitic inductance. It is recommended to minimize the series inductance of the LED wiring by:

- · Short wires
- · Thick wires / Multiple parallel wires
- Small enclosed area of the forward and return current path

If the inductance cannot be made sufficiently low, a Zener diode needs to be used to clamp the drain voltage of the RGB switch such it does not surpass the absolute maximum rating. The clamping voltage need to be chosen between the maximum expected V<sub>LED</sub> and the absolute maximum rating. Take care of sufficient margin of the clamping voltage relative to the mentioned minimum and maximum voltage.

#### 10.2 Layout Example

A layout example of a buck converter is shown in Figure 10-4, illustrating the optimal routing and placement of components around the DLPA3005. This can be used as a reference for a general purpose buck2 (PWR6). The layout example illustrates the inductor and its accompanying capacitors as close as possible to their corresponding pins using the thickest possible traces. The capacitors use multiple vias to the ground layer to ensure a low resistance path and minimizes the distance between the ground connections of the output capacitors and the ground connections of the buck converter.

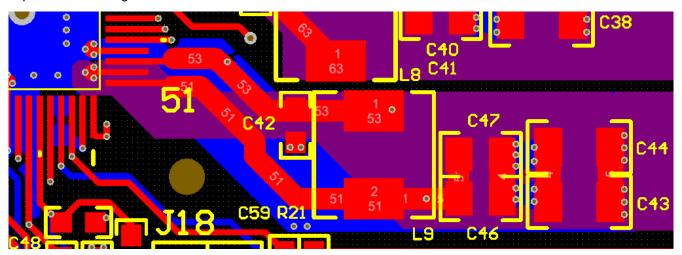


Figure 10-4. Practical Layout

A proper layout requires short traces and separate power grounds to avoid losses from trace resistance and to avoid ground shifting. Use high quality capacitors with low ESR to keep capacitor losses minimal and to maintain an acceptable voltage ripple at the output.

Use a RC snubber network to avoid EMI that can occur when switching high currents at high frequencies. The EMI may have a higher amplitude and frequency than the switching voltage.

#### 10.3 Thermal Considerations

Power dissipation must be considered when implementing integrated circuits in low-profile and fine-pitch surface-mount packages. Many system related issues may affect power dissipation: thermal coupling, airflow, adding heat sinks and convection surfaces, and the presence of other heat-generating components. In general, there are three basic methods that can be used to improve thermal performance:

- Improve the heat sinking capability of the PCB.
- Reduce thermal resistance to the environment of the chip by adding or increasing heat sink capability on top
  of the package.
- Add or increase airflow in the system.

Power delivered to the LEDs can be greater than 50 W and the power dissipated by the DLPA3005 can be considerable. For proper DLPA3005 operation, the details below outline thermal considerations for a DLPA3005 application.

The recommended junction temperature for the DLPA3005 is below 120 $^{\circ}$ C during operation. The equation that relates junction temperature,  $T_{junction}$ , is given by:

$$T_{junction} = T_{ambient} + P_{diss} \times R_{\theta JA}$$
 (13)

where  $T_{ambient}$  is the ambient temperature,  $P_{diss}$  is the total power dissipation, and  $R_{\theta JA}$  is the thermal resistance from junction to ambient.

The total power dissipation may vary depending on the application of the DLPA3005. The main contributors in the DLPA3005 are typically:

- Buck converters
- LDOs

For the buck converter, the power dissipation is given by:

$$P_{diss\_buck} = P_{in} - P_{out} = P_{out} \left( \frac{1}{\eta_{buck}} - 1 \right)$$
(14)

where  $\eta_{buck}$  is the efficiency of the buck converter,  $P_{in}$  is the power delivered to the input of the buck converter, and  $P_{out}$  is the power delivered to the load of the buck converter. For the buck converter PWR1,2,6, the efficiency can be determined using the curves in Figure 7-16.

For the LDO, the power dissipation is given by:

$$P_{diss\_LDO} = (V_{in} - V_{out}) \times I_{load}$$
(15)

where  $V_{in}$  is the input supply voltage,  $V_{out}$  is the output voltage of the LDO, and  $I_{load}$  is the load current of the LDO. The voltage drops over the LDO ( $V_{in}$ - $V_{out}$ ) can be relatively large; a small load current can result in significant power dissipation. For this situation, a general purpose buck converter can be a more efficient solution.

The LDO DMD provides power to the boost converter, and the boost converter provides high voltages for the DMD; that is,  $V_{BIAS}$ ,  $V_{OFS}$ ,  $V_{RST}$ . The current load on these lines can increase up to  $I_{load,max}$ =10 mA. Assuming the efficiency of the boost converter,  $\eta_{boost}$ , is 80%, the maximum boost converter power dissipation,  $P_{diss\ DMD\ boost,max}$ , can be calculated as:

$$P_{diss\_DMD\_boost,max} = I_{load,max} \left( V_{BIAS} + V_{OFS} + |V_{RST}| \right) \times \left( \frac{1}{\eta_{boost}} - 1 \right) \approx 0.1W$$
(16)

Compared to the power dissipation of the illumination buck converter, the power dissipation of the boost converter is negligible. However, the power dissipation of the LDO DMD,  $P_{diss\_LDO\_DMD}$  should be given consideration in the case of a high supply voltage. The worst-case load current for the LDO is given by:

$$I_{load\_LDO,max} = \frac{1}{\eta_{boost}} \frac{\left(V_{BIAS} + V_{OFS} + \left|V_{RST}\right|\right)}{V_{DRST\_5P5V}} I_{load,max} \approx 100 \text{mA}$$
(17)

where the output voltage of the LDO is  $V_{DRST}$  <sub>5P5V</sub>= 5.5 V.

The worst-case power dissipation of the LDO DMD is approximately 1.5 W when the input supply voltage is 19.5 V. For your specific application, it is recommended to check the LDO current level. Therefore, the total power dissipation of the DLPA3005 can be described as:

$$P_{diss\_DLPA3005} = \sum P_{buck\_converter} + \sum P_{LDOs}$$
(18)

The following examples calculate of the maximum ambient temperature and the junction temperature based on known information.

If it is assumed that the total dissipation  $P_{diss\_DLPA3005}$ = 2.5 W,  $T_{junction,max}$ = 120°C, and  $R_{\theta JA}$ = 7°C/W (refer to *Section 6.4*), then the maximum ambient temperature can be calculated using Equation 13:

$$T_{ambient,max} = T_{junction,max} - P_{diss} \times R_{0JA} = 120^{\circ}C - 2.5W \times 7^{\circ}C/W = 102.5^{\circ}C$$

$$\tag{19}$$

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If the total power dissipation and the ambient temperature are known as:

$$T_{ambient} = 50 \text{ °C}, R_{\theta JA} = 7 \text{ °C/W}, P_{diss DLPA3005} = 4 \text{ W}.$$

$$(20)$$

the junction temperature can be calculated:

$$T_{junction} = T_{ambient} + P_{diss} \times R_{\theta JA} = 50^{\circ}C + 4W \times 7^{\circ}C/W = 78^{\circ}C$$
(21)

If the combination of ambient temperature and the total power dissipation of the DLPA3005 does not produce an acceptable junction temperature, that is, <120°C, there are two approaches:

- 1. Use larger heat sink or more airflow to reduced  $R_{\theta JA}$ .
- 2. Reduce power dissipation in DLPA3005:
  - Use an external buck converter instead of an internal general purpose buck converter.
  - · Reduce load current for the buck converter.



## 11 Device and Documentation Support

## 11.1 Device Support

#### 11.1.1 Device Nomenclature

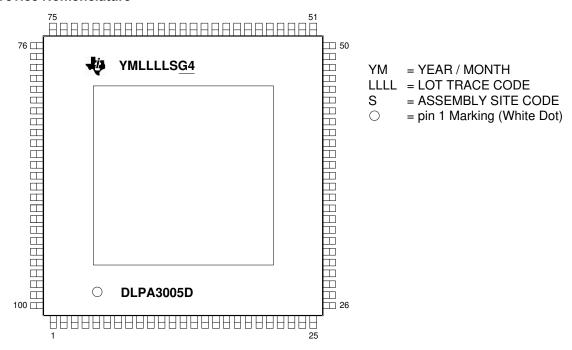


Figure 11-1. Package Marking DLPA3005 (Top View)

## 11.2 Third-Party Products Disclaimer

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#### 11.3 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY	
DLPA3005	Click here	Click here	Click here	Click here	Click here	
DLPC3439	Click here	Click here	Click here	Click here	Click here	

Table 11-1. Related Links

## 11.4 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

## 11.5 Support Resources

TI E2E<sup>™</sup> support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.



#### 11.6 Trademarks

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DLP® is a registered trademark of Texas Instruments.

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#### 11.7 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### 11.8 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

## 12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

Submit Document Feedback



## 12.1 Package Option Addendum

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>	Op Temp (°C)	Device Marking <sup>(4) (5)</sup>
DLPA3005CPFD	LIFEBUY	HTQFP	PFD	100		TBD	Call TI	Level-2-260C-1 YEAR	0 to 70	DLPA3005C
DLPA3005CPFDR	LIFEBUY	HTQFP	PFD	100		TBD	Call TI	Level-2-260C-1 YEAR	0 to 70	DLPA3005C
DLPA3005DPFD	ACTIVE	HTQFP	PFD	100	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	0 to 70	DLPA3005D
DLPA3005DPFDR	ACTIVE	HTQFP	PFD	100	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	0 to 70	DLPA3005D

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PRE PROD Unannounced device, not in production, not available for mass market, nor on the web, samples not available.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

- (3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device
- (5) Multiple Device markings will be inside parentheses. Only on Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

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www.ti.com 7-Oct-2025

#### PACKAGING INFORMATION

Orderable part number	Status	Material type	Package   Pins	Package qty   Carrier	RoHS	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
						(4)	(5)		
DLPA3005DPFD	Active	Production	HTQFP (PFD)   100	90   JEDEC TRAY (10+1)	Yes	NIPDAU	Level-2-260C-1 YEAR	0 to 70	DLPA3005D
DLPA3005DPFD.B	Active	Production	HTQFP (PFD)   100	90   JEDEC TRAY (10+1)	Yes	NIPDAU	Level-2-260C-1 YEAR	0 to 70	DLPA3005D
DLPA3005DPFDR	Active	Production	HTQFP (PFD)   100	1000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	0 to 70	DLPA3005D
DLPA3005DPFDR.B	Active	Production	HTQFP (PFD)   100	1000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	0 to 70	DLPA3005D

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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<sup>(2)</sup> Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

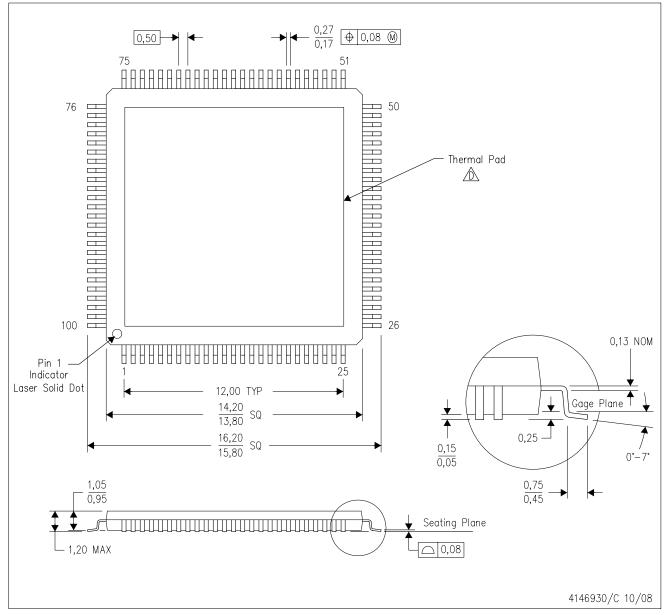
<sup>(3)</sup> RoHS values: Yes, No. RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

# PFD (S-PQFP-G100) PowerPAD™ PLASTIC QUAD FLATPACK (DIE DOWN)



NOTES:

- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion
- This package is designed to be attached directly to an external heatsink. Refer to Technical Brief, PowerPad Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 for information regarding recommended board layout. This document is available at www.ti.com <a href="https://www.ti.com">http://www.ti.com</a>. See the product data sheet for details regarding the exposed thermal pad dimensions.
- E. Falls within JEDEC MS-026

PowerPAD is a trademark of Texas Instruments.



# PFD (S-PQFP-G100)

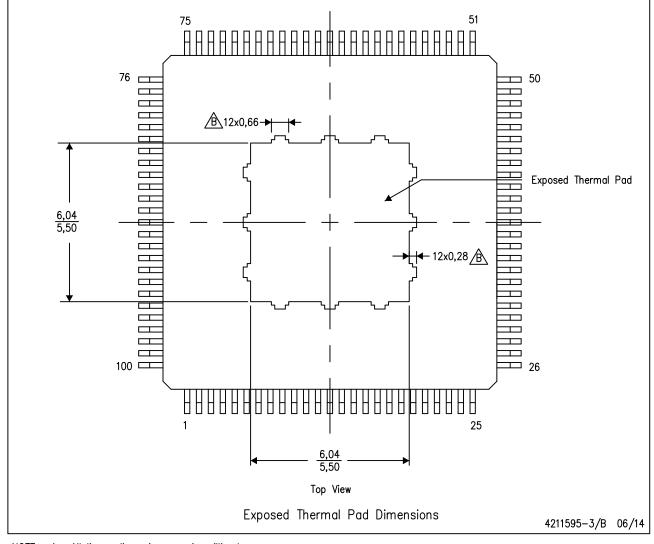
PowerPAD™ PLASTIC QUAD FLATPACK

## THERMAL INFORMATION

This PowerPAD™ package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. This design optimizes the heat transfer from the integrated circuit (IC).

For additional information on the PowerPAD package and how to take advantage of its heat dissipating abilities, refer to Technical Brief, PowerPAD Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 and Application Brief, PowerPAD Made Easy, Texas Instruments Literature No. SLMA004. Both documents are available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



NOTE: A. All linear dimensions are in millimeters

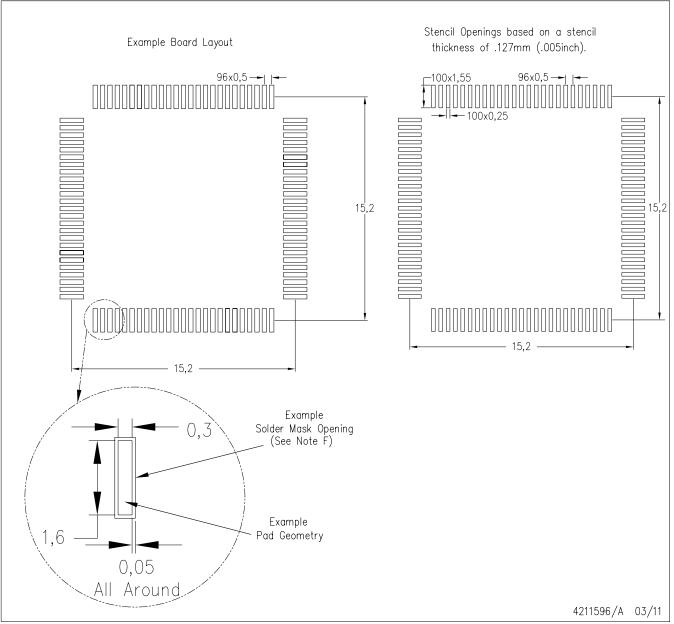
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PowerPAD is a trademark of Texas Instruments



# PFD (S-PQFP-G100)

# PowerPAD™ PLASTIC QUAD FLATPACK



NOTES:

- All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.
  Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

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